

RF Test Report

For

Applicant Name:

Address:

EUT Name:

Brand Name:

Model Number:

Shenzhen KingAnDa Technology Development Co., Ltd. East Block NO. 2, Shangxue Industrial Zone, Bantian Street, Longgang District, Shenzhen, China Bluetooth headset YYK

Issued By

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park,
Address:	Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

Report Number: Test Standards: BTF240522R00401 47 CFR Part 15.247

YYK-Q16S

Test Conclusion: FCC ID: Test Date: Date of Issue: Pass 2AOZMYYK-Q16S 2024-05-23 to 2024-06-22 2024-06-22

Prepared By:

Date:

Approved By:

Date:



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Revision History			
Version	Issue Date	Revisions Content	
R_V0	2024-06-22	Original	
Note: Once the revision has been made, then previous versions reports are invalid.		_	

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1 Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.	
Address: F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China		
Phone Number:	+86-0755-23146130	
Fax Number:	+86-0755-23146130	
FCC Registration Number:	518915	
Designation Number: CN1330		

1.3 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.

(5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

(6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.



2 **Product Information**

2.1 Application Information

Company Name:	Shenzhen KingAnDa Technology Development Co., Ltd.	
Address:	East Block NO. 2, Shangxue Industrial Zone, Bantian Street, Longgang District, Shenzhen, China	
0.0 Menufactures lafermetics		

2.2 Manufacturer Information

Company Name:	Shenzhen KingAnDa Technology Development Co., Ltd.
Address:	East Block NO. 2, Shangxue Industrial Zone, Bantian Street, Longgang District, Shenzhen, China

2.3 Factory Information

Company Name:	Shenzhen KingAnDa Technology Development Co., Ltd.
Address:	East Block NO. 2, Shangxue Industrial Zone, Bantian Street, Longgang District, Shenzhen, China

2.4 General Description of Equipment under Test (EUT)

EUT Name:		Bluetooth headset
	Test Model Number:	YYK-Q16S

5.4

2.5 Technical Information

Power Supply:	DC 5V From Adapter
Ratings:	Input: 5Vdc,1A
Battery	Headset:3.7V 40mAh Earphone Case:3.7V 1.85Wh 500mAh
Operation Frequency:	2402MHz to 2480MHz
Number of Channels:	79
Modulation Type:	GFSK, π/4 DQPSK, 8DPSK
Antenna Type:	Chip Antenna
Antenna Gain [#] :	1.15dBi
Note: #: The antenna gain provided by the applicant, and the laboratory will not be responsible for the accumulat calculation results which covers the information provided by the applicant.	

Bluetooth Version:



3 Summary of Test Results

3.1 Test Standards

The tests were performed according to following standards:

47 CFR Part 15.247: Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz

3.2 Uncertainty of Test

Item	Measurement Uncertainty
Conducted Emission (150 kHz-30 MHz)	±2.64dB
Occupied Bandwidth	±69kHz
Transmitter Power, Conducted	±0.87dB
Conducted Spurious Emissions	±0.95dB
Radiated Spurious Emissions (above 1GHz)	1-6GHz: ±3.94dB
	6-18GHz: ±4.16dB
Radiated Spurious Emissions (30M - 1GHz)	±4.12dB
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The following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

3.3 Summary of Test Result

Item	Standard	Requirement	Result
Antenna requirement	47 CFR Part 15.247	47 CFR 15.203	Pass
Conducted Emission at AC power line	47 CFR Part 15.247	47 CFR 15.207(a)	Pass
Occupied Bandwidth	47 CFR Part 15.247	47 CFR 15.215(c)	Pass
Maximum Conducted Output Power	47 CFR Part 15.247	47 CFR 15.247(b)(1)	Pass
Channel Separation	47 CFR Part 15.247	47 CFR 15.247(a)(1)	Pass
Number of Hopping Frequencies	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
Dwell Time	47 CFR Part 15.247	47 CFR 15.247(a)(1)(iii)	Pass
Emissions in non-restricted frequency bands	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
Band edge emissions (Radiated)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
Emissions in frequency bands (below 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass
Emissions in frequency bands (above 1GHz)	47 CFR Part 15.247	47 CFR 15.247(d), 15.209, 15.205	Pass



4 Test Configuration

4.1 Test Equipment List

Conducted Emission at AC power line							
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date		
Pulse Limiter	SCHWARZBECK	VTSD 9561-F	00953	2023-11-13	2024-11-12		
Coaxial Switcher	SCHWARZBECK	CX210	CX210	2023-11-13	2024-11-12		
V-LISN	SCHWARZBECK	NSLK 8127	01073	2023-11-16	2024-11-15		
LISN	AFJ	LS16/110VAC	16010020076	2023-11-16	2024-11-15		
EMI Receiver	ROHDE&SCHWA RZ	ESCI3	101422	2023-11-15	2024-11-14		

Occupied Bandwidth Maximum Conducted Channel Separation Number of Hopping F Dwell Time Emissions in non-res	requencies	ands			
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
RFTest software	/	V1.00	/	/	/
RF Control Unit	Techy	TR1029-1	/	2023-11-13	2024-11-12
RF Sensor Unit	Techy	TR1029-2	/	2023-11-13	2024-11-12
Programmable constant temperature and humidity box	ZZCKONG	ZZ-K02A	20210928007	2023-11-16	2024-11-15
Adjustable Direct Current Regulated Power Supply	Dongguan Tongmen Electronic Technology Co., LTD	etm-6050c	20211026123	2023-11-13	2024-11-12
WIDEBAND RADIO COMMNUNICATION TESTER	Rohde & Schwarz	CMW500	161997	2023-11-16	2024-11-15
MXA Signal Analyzer	KEYSIGHT	N9020A	MY50410020	2023-11-16	2024-11-15



Band edge emissions (Radiated) Emissions in frequency bands (below 1GHz) Emissions in frequency bands (above 1GHz)						
Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date	
Coaxial cable Multiflex 141	Schwarzbeck	N/SMA 0.5m	517386	2023-11-13	2024-11-12	
Preamplifier	SCHWARZBECK	BBV9744	00246	2023-11-13	2024-11-12	
RE Cable	REBES Talent	UF1-SMASMAM-1 0m	21101566	2023-11-13	2024-11-12	
RE Cable	REBES Talent	UF2-NMNM-10m	21101570	2023-11-13	2024-11-12	
RE Cable	REBES Talent	UF1-SMASMAM-1 m	21101568	2023-11-13	2024-11-12	
RE Cable	REBES Talent	UF2-NMNM-1m	21101576	2023-11-13	2024-11-12	
RE Cable	REBES Talent	UF2-NMNM-2.5m	21101573	2023-11-13	2024-11-12	
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	2023-11-13	2024-11-12	
Horn Antenna	SCHWARZBECK	BBHA9170	01157	2023-11-13	2024-11-12	
EMI TEST RECEIVER	ROHDE&SCHWA RZ	ESCI7	101032	2023-11-16	2024-11-15	
SIGNAL ANALYZER	ROHDE&SCHWA RZ	FSQ40	100010	2023-11-16	2024-11-15	
POSITIONAL CONTROLLER	SKET	PCI-GPIB	/	2023-11-13	2024-11-12	
Broadband Preamplilifier	SCHWARZBECK	BBV9718D	00008	2023-11-16	2024-11-15	
Horn Antenna	SCHWARZBECK	BBHA9120D	2597	2023-11-16	2024-11-15	
EZ_EMC	Frad	FA-03A2 RE+	/	/	/	
POSITIONAL CONTROLLER	SKET	PCI-GPIB	1	2023-11-13	2024-11-12	
Log periodic antenna	SCHWARZBECK	VULB 9168	01328	2023-11-13	2024-11-12	



4.2 Test Auxiliary Equipment

The EUT was tested as an independent device.

4.3 Test Modes

No.	Test Modes	Description
TM1	TX-GFSK (Non-Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with GFSK modulation.
TM2	TX-Pi/4DQPSK (Non-Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with Pi/4DQPSK modulation.
ТМЗ	TX-8DPSK (Non-Hopping)	Keep the EUT in continuously transmitting mode (non-hopping) with 8DPSK modulation.
TM4	TX-GFSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with GFSK modulation,.
TM5	TX-Pi/4DQPSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with Pi/4DQPSK modulation.
TM6	TX-8DPSK (Hopping)	Keep the EUT in continuously transmitting mode (hopping) with 8DPSK modulation.



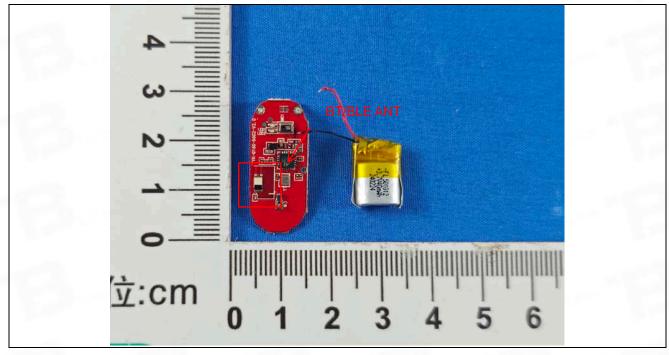
5 Evaluation Results (Evaluation)

5.1 Antenna requirement

Refer to 47 CFR Part 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section.

5.1.1 Conclusion:

Test Requirement:





6 Radio Spectrum Matter Test Results (RF)

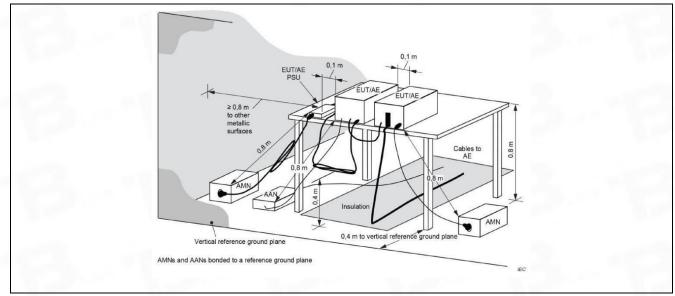
6.1 Conducted Emission at AC power line

Test Requirement:	Refer to 47 CFR 15.207(a), Except as shown in paragraphs (b)and (c)of this section, for an intentional radiator that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies, within the band 150 kHz to 30 MHz, shall not exceed the limits in the following table, as measured using a 50 μ H/50 ohms line impedance stabilization network (LISN).				
Test Method:	ANSI C63.10-2013 section 6.2				
	Frequency of emission (MHz)	Conducted limit (dB	μV)		
		Quasi-peak	Average		
Test Limit:	0.15-0.5	66 to 56*	56 to 46*		
Test Linnt.	0.5-5	56	46		
	5-30 60 50				
	*Decreases with the logarithm of the frequency.				
Procedure:	Refer to ANSI C63.10-2013 section 6.2, standard test method for ac power-line conducted emissions from unlicensed wireless devices				

6.1.1 E.U.T. Operation:

Operating Environment:		
Temperature:	24.3 °C	
Humidity:	54 %	
Atmospheric Pressure:	1010 mbar	

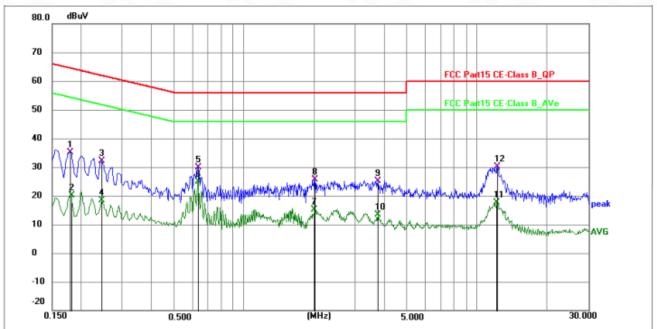
6.1.2 Test Setup Diagram:





6.1.3 Test Data:

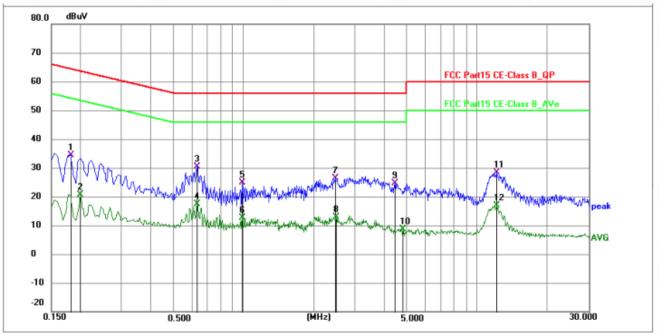
TM1 / Line: Line / Band: 2400-2483.5 MHz / BW: 1 / CH: M



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.1796	24.67	10.52	35.19	64.50	-29.31	QP	Р	
2	0.1815	9.54	10.52	20.06	54.42	-34.36	AVG	Р	
3	0.2445	21.56	10.56	32.12	61.94	-29.82	QP	Р	
4	0.2445	7.94	10.56	18.50	51.94	-33.44	AVG	Р	
5	0.6360	19.20	10.65	29.85	56.00	-26.15	QP	Р	
6 *	0.6360	14.33	10.65	24.98	46.00	-21.02	AVG	Р	
7	2.0040	4.36	10.68	15.04	46.00	-30.96	AVG	Р	
8	2.0220	14.96	10.68	25.64	56.00	-30.36	QP	Р	
9	3.7545	14.58	10.66	25.24	56.00	-30.76	QP	Р	
10	3.7545	2.80	10.66	13.46	46.00	-32.54	AVG	Р	
11	12.1875	6.76	10.87	17.63	50.00	-32.37	AVG	Р	
12	12.2145	19.16	10.87	30.03	60.00	-29.97	QP	Р	

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TM1 / Line: Neutral / Band: 2400-2483.5 MHz / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector	P/F	Remark
1	0.1815	23.89	10.52	34.41	64.42	-30.01	QP	Ρ	
2	0.1995	9.96	10.56	20.52	53.63	-33.11	AVG	Р	
3 *	0.6315	19.77	10.65	30.42	56.00	-25.58	QP	Р	
4	0.6315	6.83	10.65	17.48	46.00	-28.52	AVG	Р	
5	0.9870	14.18	10.66	24.84	56.00	-31.16	QP	Ρ	
6	0.9870	1.96	10.66	12.62	46.00	-33.38	AVG	Р	
7	2.4630	15.69	10.67	26.36	56.00	-29.64	QP	Р	
8	2.4900	2.27	10.67	12.94	46.00	-33.06	AVG	Р	
9	4.4430	13.98	10.70	24.68	56.00	-31.32	QP	Р	
10	4.8075	-2.13	10.72	8.59	46.00	-37.41	AVG	Ρ	
11	12.1155	17.61	10.83	28.44	60.00	-31.56	QP	Ρ	
12	12.1155	5.97	10.83	16.80	50.00	-33.20	AVG	Ρ	



6.2 Occupied Bandwidth

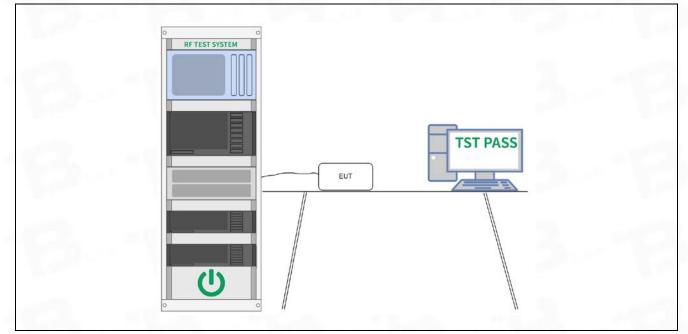
Test Requirement:	47 CFR 15.215(c)
	ANSI C63.10-2013, section 7.8.7, For occupied bandwidth measurements, use the
Test Method:	procedure in 6.9.2.
	KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.215(c), intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§ 15.217 through 15.257 and in subpart E of this part, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.
	 a) The spectrum analyzer center frequency is set to the nominal EUT channel center frequency. The span range for the EMI receiver or spectrum analyzer shall be between two times and five times the OBW. b) The nominal IF filter bandwidth (3 dB RBW) shall be in the range of 1% to 5% of the OBW and video bandwidth (VBW) shall be approximately three times RBW, unless otherwise specified by the applicable requirement. c) Set the reference level of the instrument as required, keeping the signal from exceeding the maximum input mixer level for linear operation. In general, the peak of the spectral envelope shall be more than [10 log (OBW/RBW)] below the reference level. Specific guidance is given in 4.1.5.2.
	 d) Steps a) through c) might require iteration to adjust within the specified tolerances. e) The dynamic range of the instrument at the selected RBW shall be more than 10 dB below the target "-xx dB down" requirement; that is, if the requirement calls for measuring the -20 dB OBW, the instrument noise floor at the selected RBW shall be at least 30 dB below the reference value.
Procedure:	 f) Set detection mode to peak and trace mode to max hold. g) Determine the reference value: Set the EUT to transmit an unmodulated carrier or modulated signal, as applicable. Allow the trace to stabilize. Set the spectrum analyzer marker to the highest level of the displayed trace (this is the reference value).
	 h) Determine the "-xx dB down amplitude" using [(reference value) - xx]. Alternatively, this calculation may be made by using the marker-delta function of the instrument.
	i) If the reference value is determined by an unmodulated carrier, then turn the EUT modulation ON, and either clear the existing trace or start a new trace on the spectrum analyzer and allow the new trace to stabilize. Otherwise, the trace from step g) shall be used for step j).
	j) Place two markers, one at the lowest frequency and the other at the highest frequency of the envelope of the spectral display, such that each marker is at or slightly below the "-xx dB down amplitude" determined in step h). If a marker is below this "-xx dB down amplitude" value, then it shall be as close as possible to
	this value. The occupied bandwidth is the frequency difference between the two markers. Alternatively, set a marker at the lowest frequency of the envelope of the spectral display, such that the marker is at or slightly below the "-xx dB down amplitude" determined in step h). Reset the marker-delta function and move the marker to the other side of the emission until the delta marker amplitude is at the same level as the reference marker amplitude. The marker-delta frequency reading at this point is the specified emission bandwidth.
	 k) The occupied bandwidth shall be reported by providing plot(s) of the measuring instrument display; the plot axes and the scale units per division shall be clearly labeled. Tabular data may be reported in addition to the plot(s).



6.2.1 E.U.T. Operation:

Operating Environment:				
Temperature:	24.1 °C	1.1	10.00	
Humidity:	56 %			
Atmospheric Pressure:	1010 mbar			-

6.2.2 Test Setup Diagram:



6.2.3 Test Data:

Please Refer to Appendix for Details.



6.3 Maximum Conducted Output Power

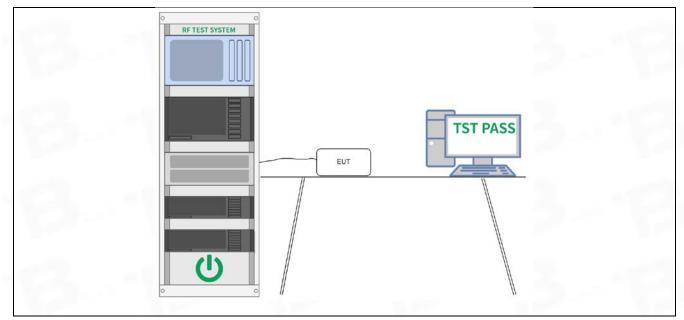
Test Requirement:	47 CFR 15.247(b)(1)
Test Method:	ANSI C63.10-2013, section 7.8.5 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(b)(1), For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band: 0.125 watts.
Procedure:	 This is an RF-conducted test to evaluate maximum peak output power. Use a direct connection between the antenna port of the unlicensed wireless device and the spectrum analyzer, through suitable attenuation. The hopping shall be disabled for this test: a) Use the following spectrum analyzer settings: 1) Span: Approximately five times the 20 dB bandwidth, centered on a hopping channel. 2) RBW > 20 dB bandwidth of the emission being measured. 3) VBW >= RBW. 4) Sweep: Auto. 5) Detector function: Peak. 6) Trace: Max hold. b) Allow trace to stabilize. c) Use the marker-to-peak function to set the marker to the peak of the emission. d) The indicated level is the peak output power, after any corrections for external attenuators and cables. e) A plot of the test results and setup description shall be included in the test report. NOTE—A peak responding power meter may be used, where the power meter and sensor system video bandwidth is greater than the occupied bandwidth of the unlicensed wireless device, rather than a spectrum analyzer.

6.3.1 E.U.T. Operation:

Operating Environment:				
Temperature:	24.1 °C			
Humidity:	56 %			
Atmospheric Pressure:	1010 mbar			
6.3.2 Test Setup Diagram:				

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6.3.3 Test Data:

Please Refer to Appendix for Details.



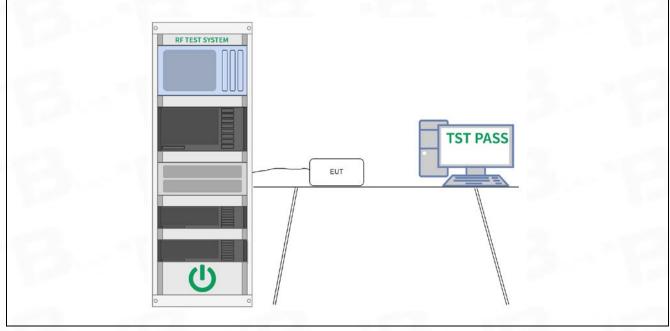
6.4 Channel Separation

Test Requirement:	47 CFR 15.247(a)(1)
Test Method:	ANSI C63.10-2013, section 7.8.2
Test Limit:	 KDB 558074 D01 15.247 Meas Guidance v05r02 Refer to 47 CFR 15.247(a)(1), Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.
Procedure:	 The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Wide enough to capture the peaks of two adjacent channels. b) RBW: Start with the RBW set to approximately 30% of the channel spacing; adjust as necessary to best identify the center of each individual channel. c) Video (or average) bandwidth (VBW) ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Compliance of an EUT with the appropriate regulatory limit shall be determined. A plot of the data shall be included in the test report.

6.4.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.1 °C
Humidity:	56 %
Atmospheric Pressure:	1010 mbar

6.4.2 Test Setup Diagram:



6.4.3 Test Data:

Please Refer to Appendix for Details.



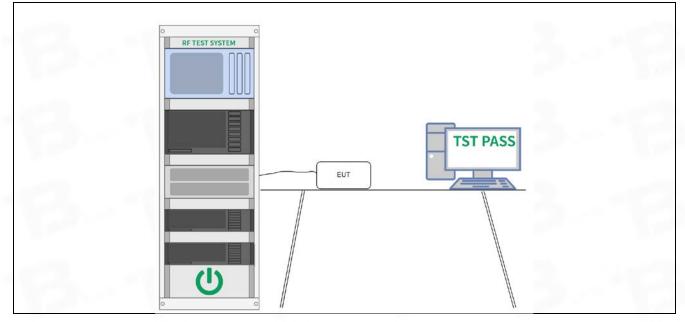
6.5 Number of Hopping Frequencies

Test Nethod: 47 Or N 15.247 (a)(1)(iii) ANSI C63.10-2013, section 7.8.3 KDB 558074 D01 15.247 Meas Guidance v05r02 Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used. The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data shall be included in the test report.	Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Method: KDB 558074 D01 15.247 Meas Guidance v05r02 Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used. The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data 	rest requirement.	
Test Limit: Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used. The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data	Test Method:	
analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data	Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency
	Procedure:	 The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: The frequency band of operation. Depending on the number of channels the device supports, it may be necessary to divide the frequency range of operation across multiple spans, to allow the individual channels to be clearly seen. b) RBW: To identify clearly the individual channels, set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller. c) VBW ≥ RBW. d) Sweep: Auto. e) Detector function: Peak. f) Trace: Max hold. g) Allow the trace to stabilize. It might prove necessary to break the span up into subranges to show clearly all of the hopping frequencies. Compliance of an EUT with the appropriate regulatory limit shall be determined for the number of hopping channels. A plot of the data

6.5.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.1 °C
Humidity:	56 %
Atmospheric Pressure:	1010 mbar

6.5.2 Test Setup Diagram:



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6.5.3 Test Data: Please Refer to Appendix for Details.



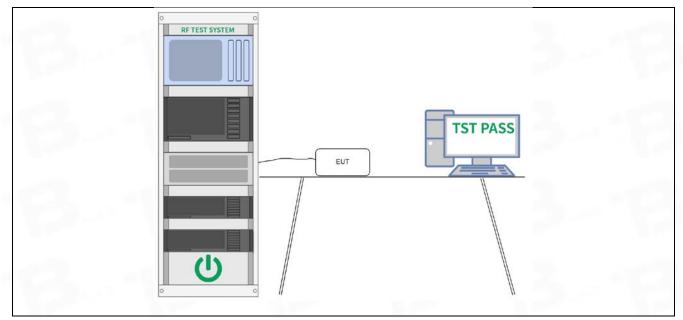
6.6 Dwell Time

Test Requirement:	47 CFR 15.247(a)(1)(iii)
Test Method:	ANSI C63.10-2013, section 7.8.4 KDB 558074 D01 15.247 Meas Guidance v05r02
Test Limit:	Refer to 47 CFR 15.247(a)(1)(iii), Fequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.
Procedure:	The EUT shall have its hopping function enabled. Use the following spectrum analyzer settings: a) Span: Zero span, centered on a hopping channel. b) RBW shall be <= channel spacing and where possible RBW should be set >> 1 / T, where T is the expected dwell time per channel. c) Sweep: As necessary to capture the entire dwell time per hopping channel; where possible use a video trigger and trigger delay so that the transmitted signal starts a little to the right of the start of the plot. The trigger level might need slight adjustment to prevent triggering when the system hops on an adjacent channel; a second plot might be needed with a longer sweep time to show two successive hops on a channel. d) Detector function: Peak. e) Trace: Max hold. Use the marker-delta function to determine the transmit time per hop. If this value varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation in transmit time. Repeat the measurement using a longer sweep time to determine the number of hops over the period specified in the requirements. The sweep time shall be equal to, or less than, the period specified in the requirements. Determine the number of hops over the sweep time and calculate the total number of hops in the period specified in the requirements) = (number of hops on spectrum analyzer) × (period specified in the requirements / analyzer sweep time) The average time of occupancy is calculated from the transmit time per hop multiplied by the number of hops in the period specified in the requirements. If the number of hops in a specific time varies with different modes of operation (data rate, modulation format, number of hopping channels, etc.), then repeat this test for each variation. The measured transmit time and time between hops shall be consistent with the
	values described in the operational description for the EUT.

6.6.1 E.U.T. Operation:

Operating Environment:				
Temperature:	24.1 °C			
Humidity:	56 %			
Atmospheric Pressure:	1010 mbar			
6.6.2 Test Setup Diagram:				





6.6.3 Test Data: Please Refer to Appendix for Details.



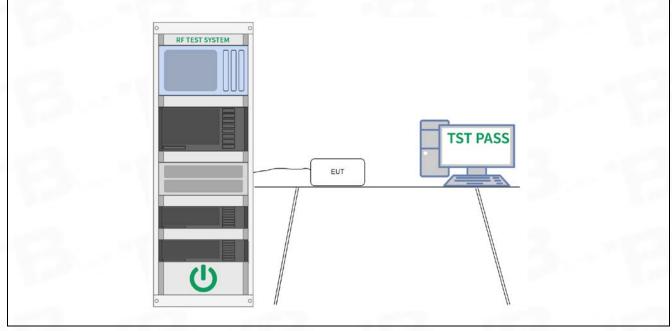
6.7 Emissions in non-restricted frequency bands

Test Requirement:	47 CFR 15.247(d), 15.209, 15.205					
Test Method:	ANSI C63.10-2013 section 7.8.8					
Test Method.	KDB 558074 D01 15.247 Meas Guidance v05r02					
Test Limit:	Refer to 47 CFR 15.247(d), In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in § 15.209(a) is not required.					
Procedure:	Conducted spurious emissions shall be measured for the transmit frequency, per 5.5 and 5.6, and at the maximum transmit powers. Connect the primary antenna port through an attenuator to the spectrum analyzer input; in the results, account for all losses between the unlicensed wireless device output and the spectrum analyzer. The instrument shall span 30 MHz to 10 times the operating frequency in GHz, with a resolution bandwidth of 100 kHz, video bandwidth of 300 kHz, and a coupled sweep time with a peak detector. The band 30 MHz to the highest frequency may be split into smaller spans, as long as the entire spectrum is covered.					

6.7.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.1 °C
Humidity:	56 %
Atmospheric Pressure:	1010 mbar

6.7.2 Test Setup Diagram:



6.7.3 Test Data:

Please Refer to Appendix for Details.

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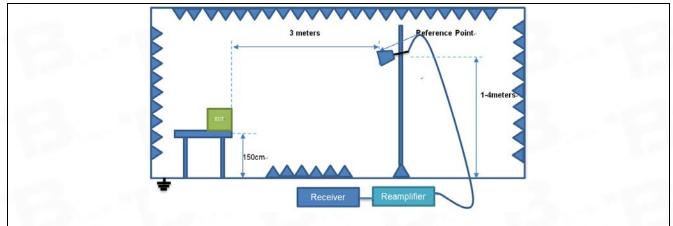
6.8 Band edge emissions (Radiated)

Test Requirement:	restricted bands, as defi	Refer to 47 CFR 15.247(d), In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).					
Test Method:	ANSI C63.10-2013 sect	ANSI C63.10-2013 section 6.10 KDB 558074 D01 15.247 Meas Guidance v05r02					
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)				
	0.009-0.490	2400/F(kHz)	300				
	0.490-1.705	24000/F(kHz)	30				
	1.705-30.0	30	30				
	30-88	100 **	3				
	88-216	150 **	3				
	216-960	200 **	3				
Test Limit:	Above 960	500	3				
	radiators operating under 54-72 MHz, 76-88 MHz, these frequency bands in 15.231 and 15.241. In the emission table ab The emission limits show employing a CISPR quar 110–490 kHz and above	In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands					
Procedure:		are based on measurements employing an average detector. ANSI C63.10-2013 section 6.10.5.2					
681 EUT Operation		011 0.10.3.2					

6.8.1 E.U.T. Operation:

Operating Environment:	
Temperature:	24.5 °C
Humidity:	56%
Atmospheric Pressure:	1010 mbar

6.8.2 Test Setup Diagram:





6.8.3 Test Data:

Note: All the mode have been tested, and only the worst case of mode are in the report TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2310.000	66.08	-30.59	35.49	74.00	-38.51	peak	Р
2	2310.000	60.70	-30.59	30.11	54.00	-23.89	AVG	Р
3	2390.000	67.40	-30.49	36.91	74.00	-37.09	peak	Р
4 *	2390.000	60.90	-30.49	30.41	54.00	-23.59	AVG	Р

TM1 / Polarization: Vertical / Band: 2400-2483.5 MHz / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2310.000	67.02	-30.59	36.43	74.00	-37.57	peak	Р
2	2310.000	60.94	-30.59	30.35	54.00	-23.65	AVG	Р
3	2390.000	67.18	-30.49	36.69	74.00	-37.31	peak	Р
4 *	2390.000	60.90	-30.49	30.41	54.00	-23.59	AVG	Р

TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: H

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	2483.500	67.23	-30.39	36.84	74.00	-37.16	peak	Р
2	2483.500	60.64	-30.39	30.25	54.00	-23.75	AVG	Р
3	2500.000	68.42	-30.37	38.05	74.00	-35.95	peak	Р
4 *	2500.000	62.78	-30.37	32.41	54.00	-21.59	AVG	Р

TM1 / Polarization: Vertical / Band: 2400-2483.5 MHz / BW: 1 / CH: H

N	No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
	1	2483.500	69.68	-30.39	39.29	74.00	-34.71	peak	Р
	2	2483.500	63.24	-30.39	32.85	54.00	-21.15	AVG	Р
	3	2500.000	69.37	-30.37	39.00	74.00	-35.00	peak	Р
4	4 *	2500.000	63.48	-30.37	33.11	54.00	-20.89	AVG	Р



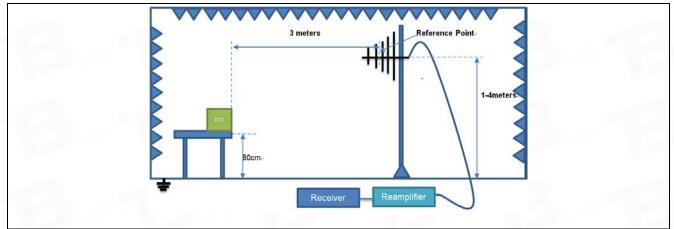
6.9 Emissions in frequency bands (below 1GHz)

Test Requirement:	restricted bands, as defi	ned in § 15.205(a), must also co	Refer to 47 CFR 15.247(d), In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).								
).`								
Test Method:	ANSI C63.10-2013 sect	ion 6.6.4 7 Meas Guidance v05r02									
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)								
	0.009-0.490	2400/F(kHz)	300								
	0.490-1.705	24000/F(kHz)	30								
	1.705-30.0	30	30								
	30-88	100 **	3								
	88-216	150 **	3								
	216-960	200 **	3								
Test Limit:	Above 960	500	3								
	 ** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands 										
Procedure:	ANSI C63.10-2013 sect	ients employing an average det									

6.9.1 E.U.T. Operation:

Operating Environment:						
Temperature:	24.6°C					
Humidity:	56 %					
Atmospheric Pressure:	1010 mbar					

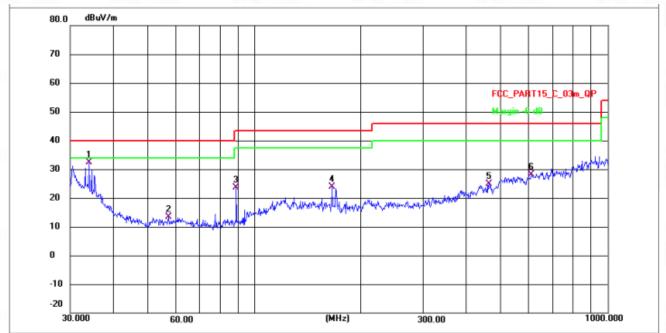
6.9.2 Test Setup Diagram:





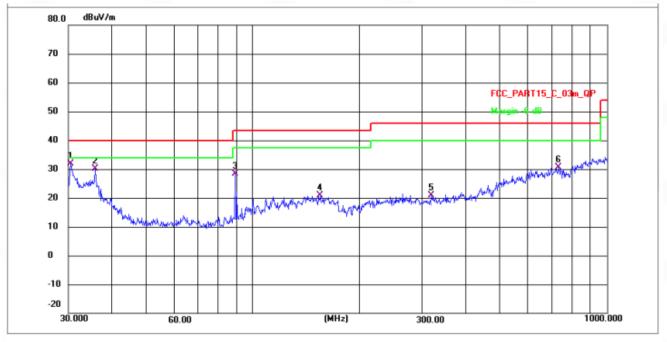
6.9.3 Test Data:

TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: M



No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1 *	33.9767	36.70	-4.30	32.40	40.00	-7.60	QP	Р
2	57.1914	17.79	-4.30	13.49	40.00	-26.51	QP	Р
3	88.9637	46.16	-22.64	23.52	43.50	-19.98	QP	Р
4	165.7770	45.62	-21.86	23.76	43.50	-19.74	QP	Р
5	461.5355	44.23	-19.32	24.91	46.00	-21.09	QP	Р
6	608.8532	46.43	-18.28	28.15	46.00	-17.85	QP	Р





TM1 / Polarization: Vertical / Band: 2400-2483.5 MHz / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1 *	30.5840	35.87	-3.89	31.98	40.00	-8.02	QP	Р
2	35.7490	34.54	-4.31	30.23	40.00	-9.77	QP	Р
3	89.1200	51.11	-22.64	28.47	43.50	-15.03	QP	Р
4	154.8204	42.87	-21.97	20.90	43.50	-22.60	QP	Р
5	318.8170	41.35	-20.47	20.88	46.00	-25.12	QP	Р
6	729.3582	48.44	-17.70	30.74	46.00	-15.26	QP	Р



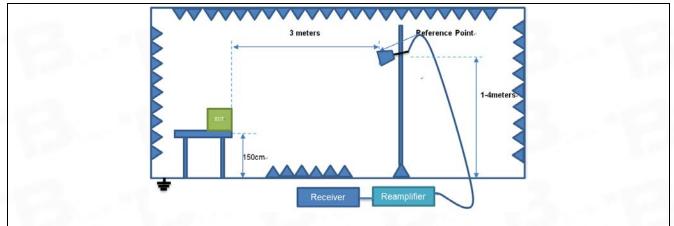
6.10 Emissions in frequency bands (above 1GHz)

Test Requirement:	15.205(a), must also co	In addition, radiated emissions which fall in the restricted bands, as defined in § 15.205(a), must also comply with the radiated emission limits specified in § 15.209(a)(see § 15.205(c)).							
Test Method:	ANSI C63.10-2013 sect								
	Frequency (MHz)	Field strength (microvolts/meter)	Measurement distance (meters)						
	0.009-0.490	2400/F(kHz)	300						
	0.490-1.705	24000/F(kHz)	30						
	1.705-30.0	30	30						
	30-88	100 **	3						
	88-216	150 **	3						
	216-960	200 **	3						
Test Limit:	Above 960	500	3						
	 ** Except as provided in paragraph (g), fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz. However, operation within these frequency bands is permitted under other sections of this part, e.g., §§ 15.231 and 15.241. In the emission table above, the tighter limit applies at the band edges. The emission limits shown in the above table are based on measurements employing a CISPR quasi-peak detector except for the frequency bands 9–90 kHz, 110–490 kHz and above 1000 MHz. Radiated emission limits in these three bands 								
Procedure:	ANSI C63.10-2013 sect	nents employing an average det ion 6 6 4							
Procedure: 6 10 1 E U T Operatio		ION 6.6.4							

6.10.1 E.U.T. Operation:

Operating Environment:						
Temperature:	24.6 °C					
Humidity:	52 %					
Atmospheric Pressure:	1010 mbar					

6.10.2Test Setup Diagram:





6.10.3Test Data:

Note: All the mode have been tested, and only the worst case of mode are in the report TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4804.000	70.08	-27.92	42.16	74.00	-31.84	peak	Р
2	4804.000	64.46	-27.92	36.54	54.00	-17.46	AVG	Р
3	7206.000	72.58	-24.87	47.71	74.00	-26.29	peak	Р
4	7206.000	65.98	-24.87	41.11	54.00	-12.89	AVG	Р
5	9608.000	72.31	-23.43	48.88	74.00	-25.12	peak	Р
6 *	9608.000	65.58	-23.43	42.15	54.00	-11.85	AVG	Р

TM1 / Polarization: Vertical / Band: 2400-2483.5 MHz / BW: 1 / CH: L

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4804.000	68.06	-27.92	40.14	74.00	-33.86	peak	Р
2	4804.000	63.04	-27.92	35.12	54.00	-18.88	AVG	Р
3	7206.000	71.94	-24.87	47.07	74.00	-26.93	peak	Р
4	7206.000	67.20	-24.87	42.33	54.00	-11.67	AVG	Р
5	9608.000	74.29	-23.43	50.86	74.00	-23.14	peak	Р
6 *	9608.000	68.28	-23.43	44.85	54.00	-9.15	AVG	Р

TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4882.000	70.69	-27.70	42.99	74.00	-31.01	peak	Р
2	4882.000	64.28	-27.70	36.58	54.00	-17.42	AVG	Р
3	7323.000	70.92	-24.83	46.09	74.00	-27.91	peak	Р
4	7323.000	64.68	-24.83	39.85	54.00	-14.15	AVG	Р
5	9764.000	71.99	-23.78	48.21	74.00	-25.79	peak	Р
6 *	9764.000	65.92	-23.78	42.14	54.00	-11.86	AVG	Р

TM1 / Polarization: Vertical / Band: 2400-2483.5 MHz / BW: 1 / CH: M

No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
1	4882.000	68.58	-27.70	40.88	74.00	-33.12	peak	Р
2	4882.000	63.11	-27.70	35.41	54.00	-18.59	AVG	Р
3	7323.000	73.18	-24.83	48.35	74.00	-25.65	peak	Р
4 *	7323.000	67.11	-24.83	42.28	54.00	-11.72	AVG	Р
5	9764.000	71.19	-23.78	47.41	74.00	-26.59	peak	Р
6	9764.000	65.92	-23.78	42.14	54.00	-11.86	AVG	Р

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	No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
[1	4960.000	68.38	-27.49	40.89	74.00	-33.11	peak	Р
	2	4960.000	62.63	-27.49	35.14	54.00	-18.86	AVG	Р
	3	7440.000	71.24	-24.80	46.44	74.00	-27.56	peak	Р
	4	7440.000	65.00	-24.80	40.20	54.00	-13.80	AVG	Р
[5	9920.000	71.96	-24.11	47.85	74.00	-26.15	peak	Р
[6*	9920.000	65.55	-24.11	41.44	54.00	-12.56	AVG	Р

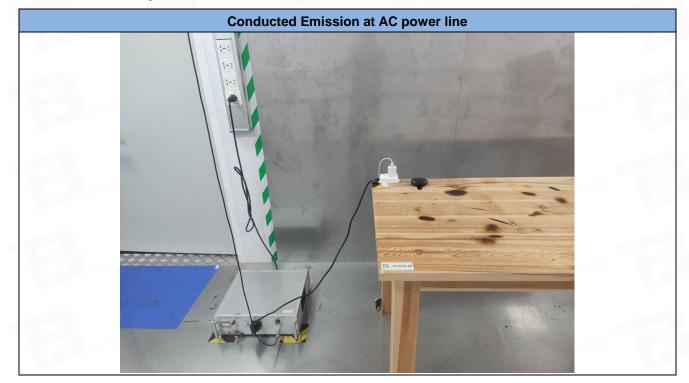
TM1 / Polarization: Horizontal / Band: 2400-2483.5 MHz / BW: 1 / CH: H

TM1 / Polarization: Vertical / Band: 2400-2483.5 MHz / BW: 1 / CH: H

	No.	Frequency (MHz)	Reading (dBuV)	Factor (dB/m)	Level (dBuV/m)	Limit (dBuV/m)	Margin (dB)	Detector	P/F
Γ	1	4960.000	72.05	-27.49	44.56	74.00	-29.44	peak	Р
	2	4960.000	66.08	-27.49	38.59	54.00	-15.41	AVG	Р
Γ	3	7440.000	71.87	-24.80	47.07	74.00	-26.93	peak	Р
	4	7440.000	65.80	-24.80	41.00	54.00	-13.00	AVG	Р
	5	9920.000	73.93	-24.11	49.82	74.00	-24.18	peak	Р
	6 *	9920.000	67.36	-24.11	43.25	54.00	-10.75	AVG	Р



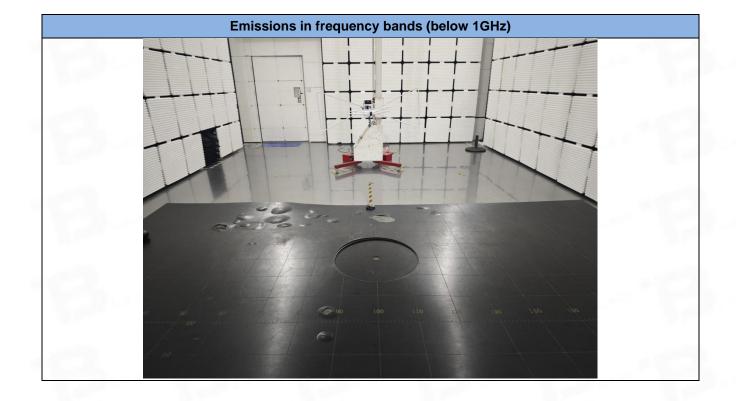
7 Test Setup Photos



Band edge emissions (Radiated) Emissions in frequency bands (above 1GHz)

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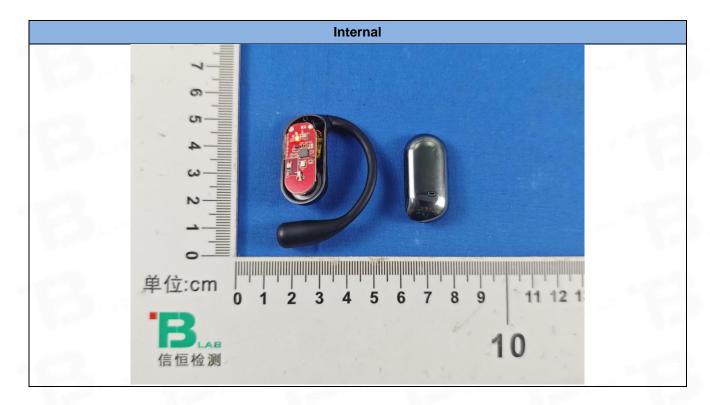


8 EUT Constructional Details (EUT Photos)



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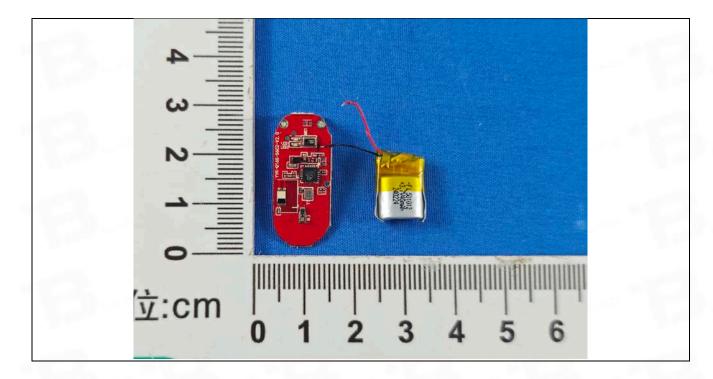


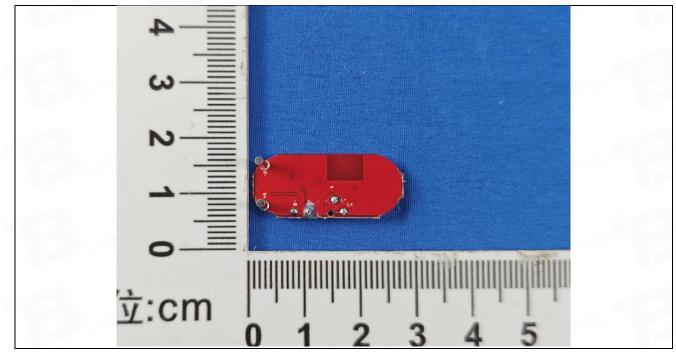




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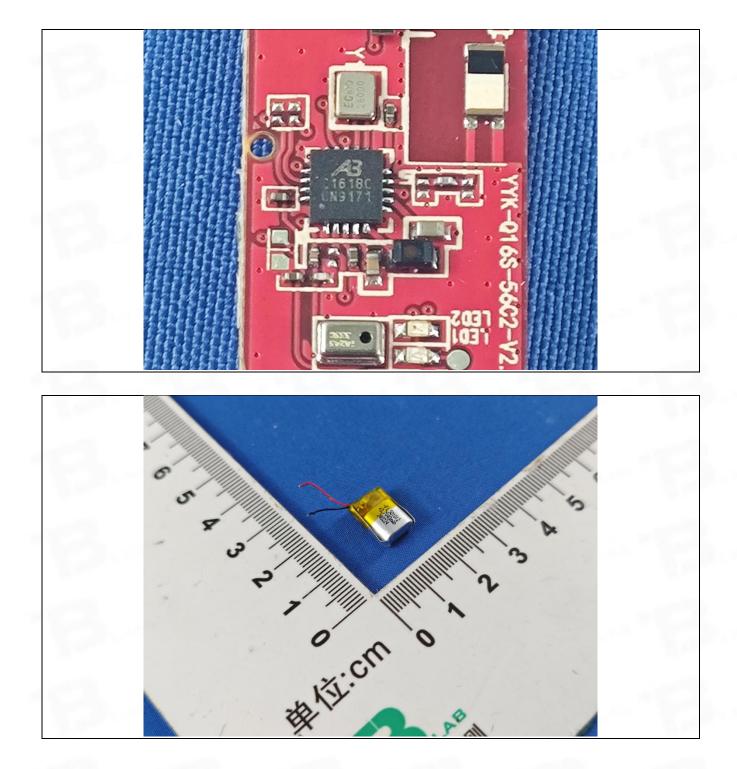






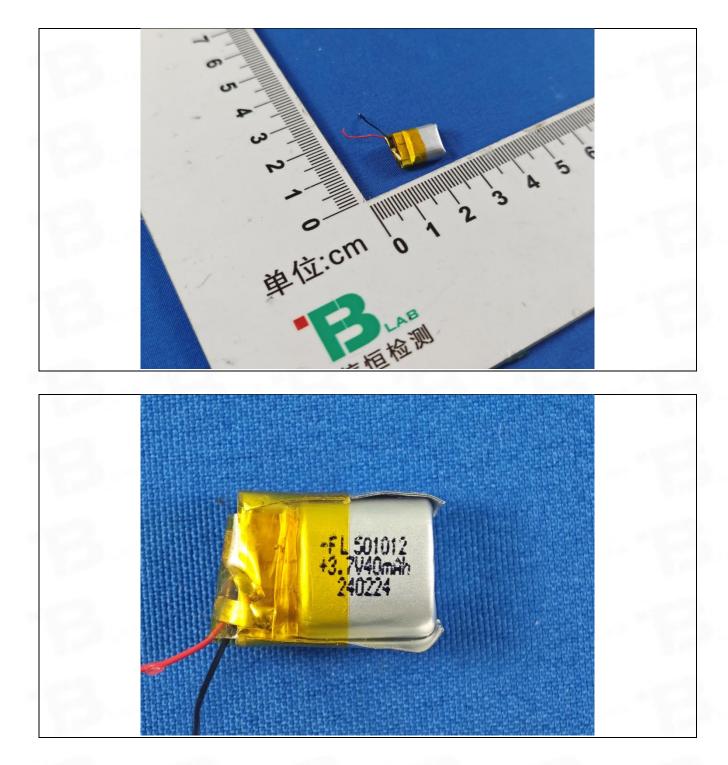
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Appendix



1. Bandwidth

1.1 OBW

1.1.1 Test Result

Mode	TX Type	Frequency Packet ANT (MHz) Type ANT	Packet	ANIT	99% Occupied E	Verdict	
			ANT	Result	Limit	verdict	
	100	2402	DH5	1	0.866	/	Pass
GFSK	SISO	2441	DH5	1	0.876	/	Pass
		2480	DH5	1	0.872	/	Pass
Pi/4DQPSK	SISO	2402	2DH5	1	1.208	/	Pass
		2441	2DH5	1	1.213	/	Pass
		2480	2DH5	1	1.187	/	Pass
8DPSK	SISO	2402	3DH5	1	1.214	/	Pass
		2441	3DH5	1	1.223	/	Pass
		2480	3DH5	1	1.191	/	Pass

1.2 20dB BW

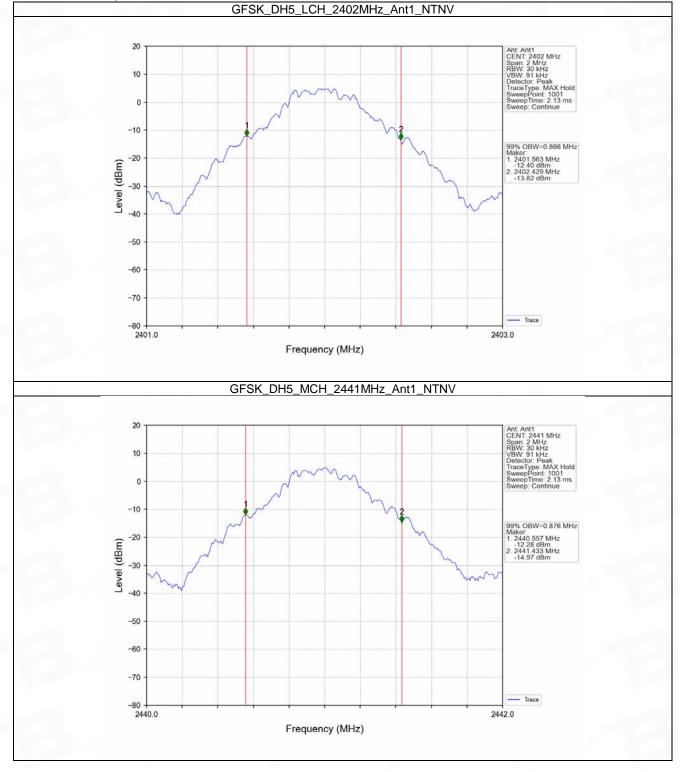
1.2.1 Test Result

Mode	TX	Frequency	Packet	ANT	20dB Bandwidth (MHz)		Verdict
	Туре	(MHz)	Туре	ANT	Result	Limit	verdict
	SISO	2402	DH5	1	0.961	/	Pass
GFSK		2441	DH5	1	0.959	/	Pass
		2480	DH5	1	0.977	/	Pass
	SISO	2402	2DH5	1	1.325	/	Pass
Pi/4DQPSK		2441	2DH5	1	1.330	/	Pass
		2480	2DH5	1	1.307	/	Pass
8DPSK	SISO	2402	3DH5	1	1.323	/	Pass
		2441	3DH5	1	1.317	/	Pass
		2480	3DH5	1	1.313	/	Pass

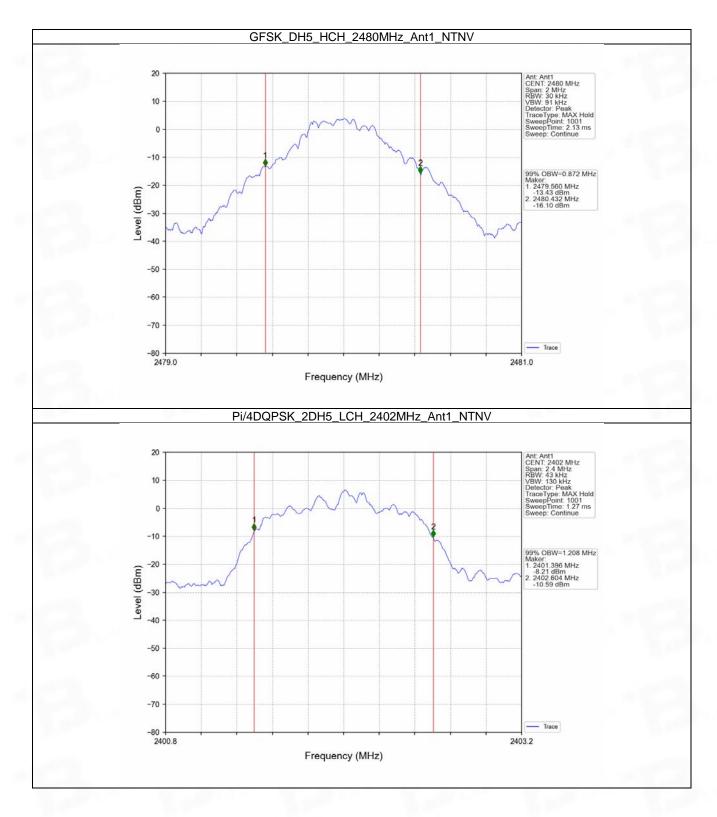
1.1 OBW



1.1.2 Test Graph

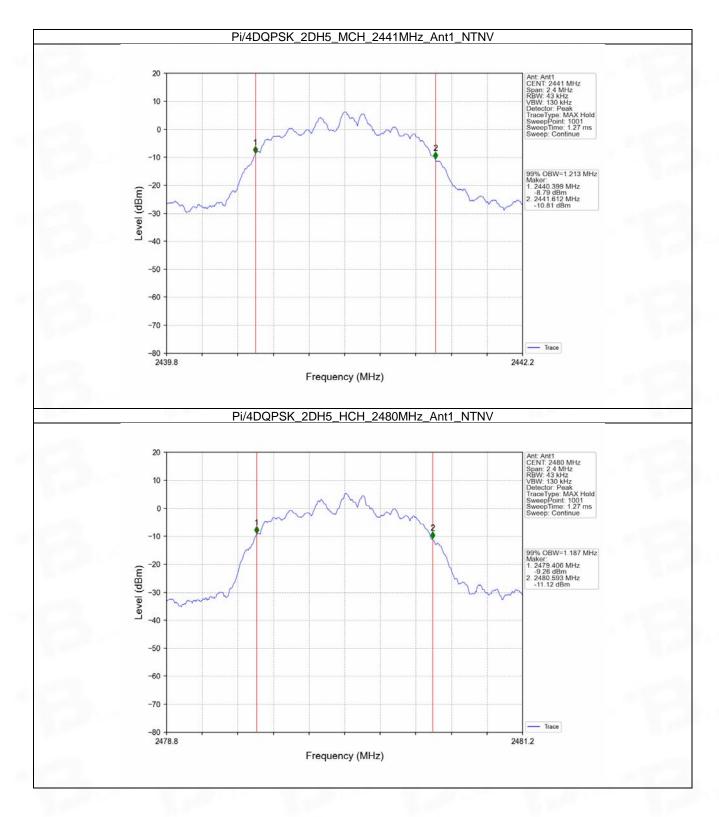






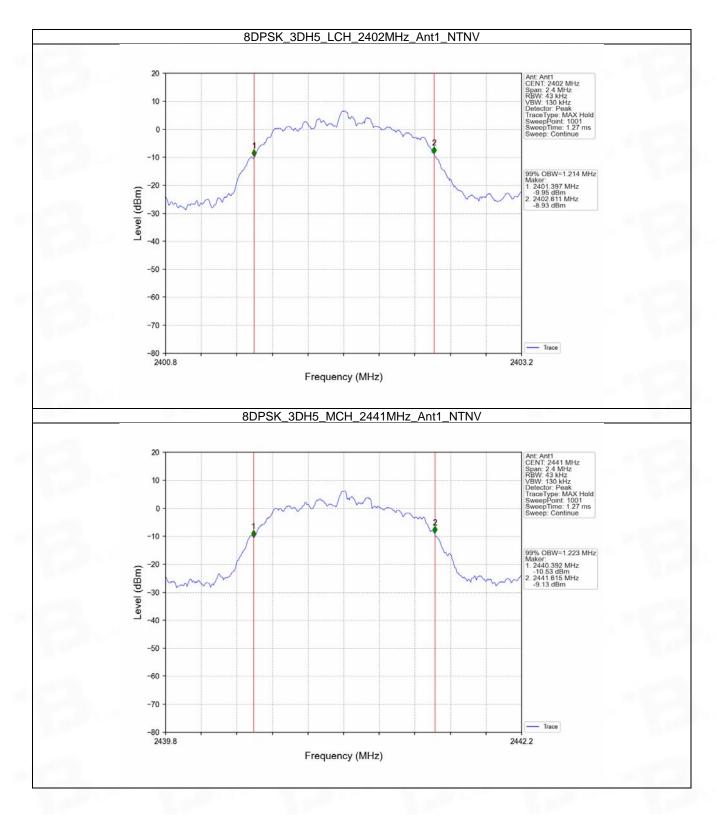
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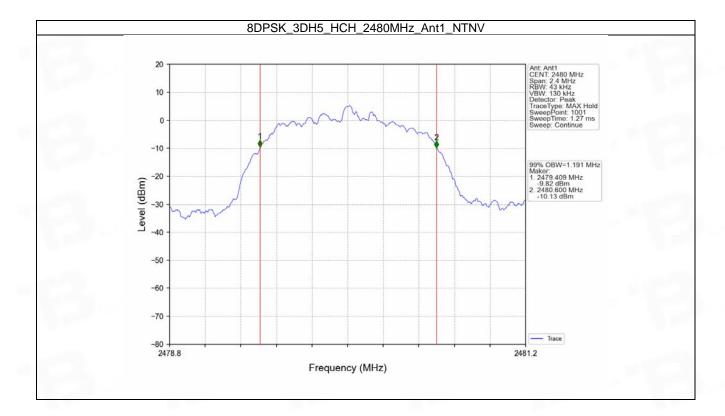
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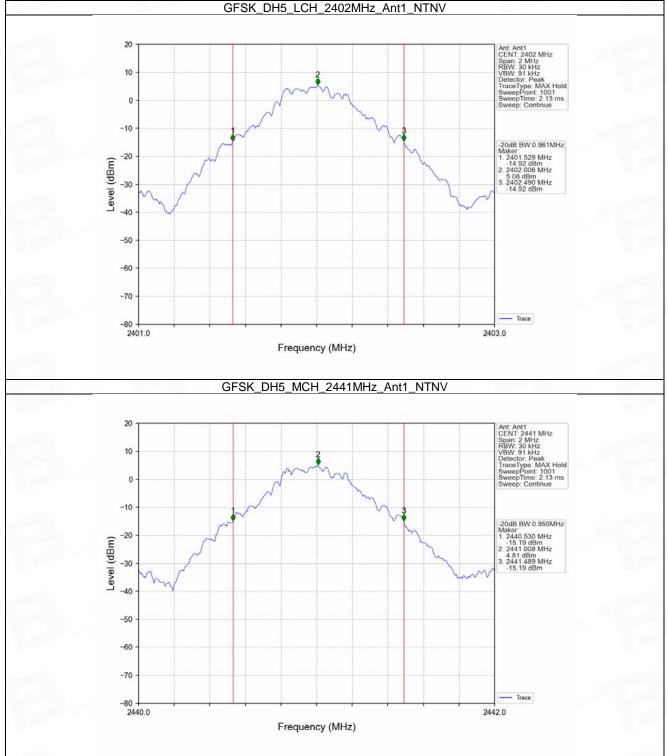






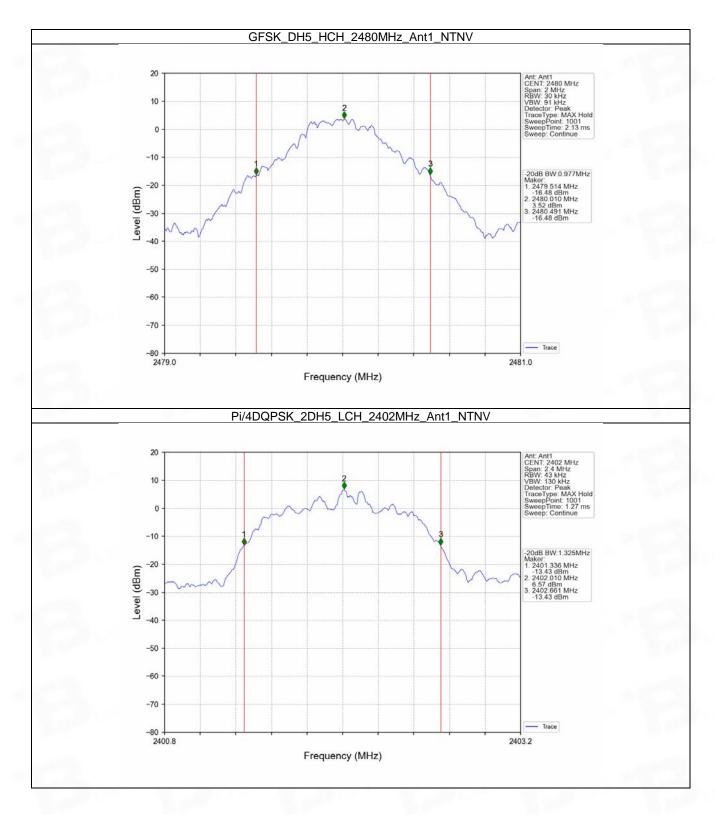
1.2 20dB BW





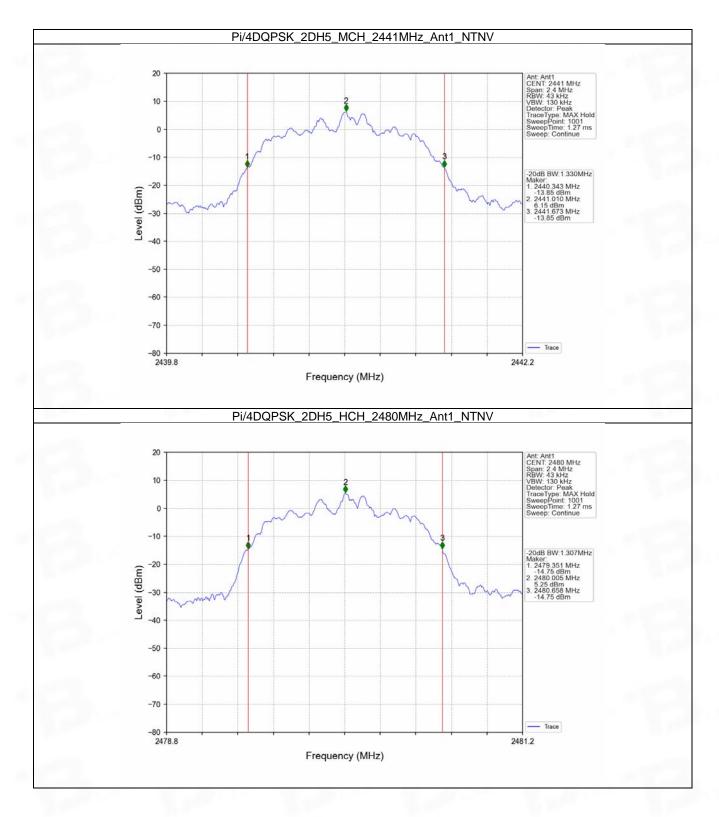
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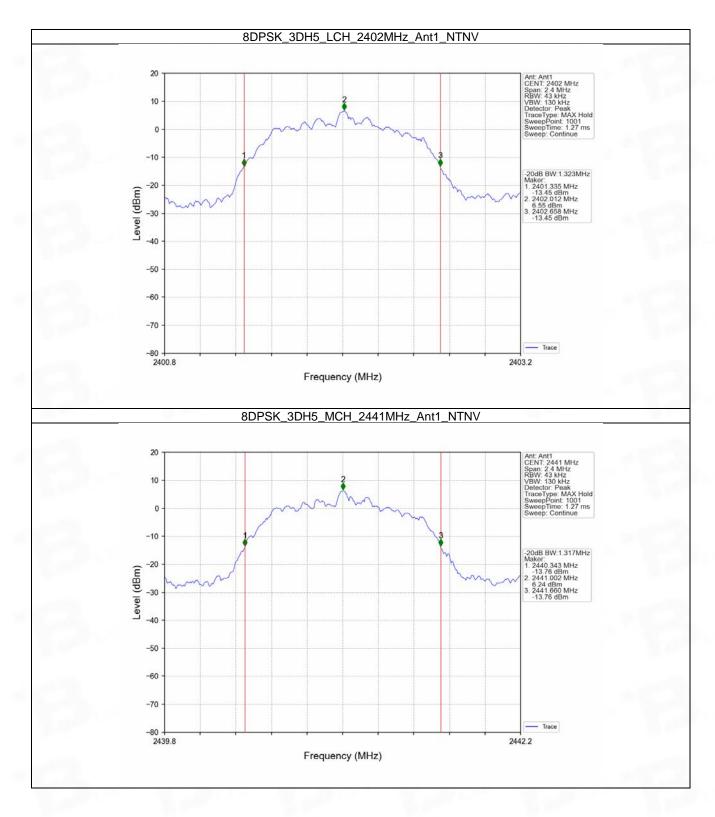
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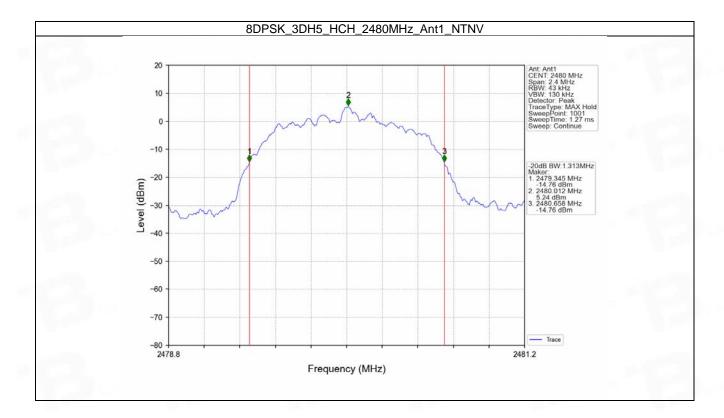
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2. Maximum Conducted Output Power

2.1 Power

2.1.1 Test Result

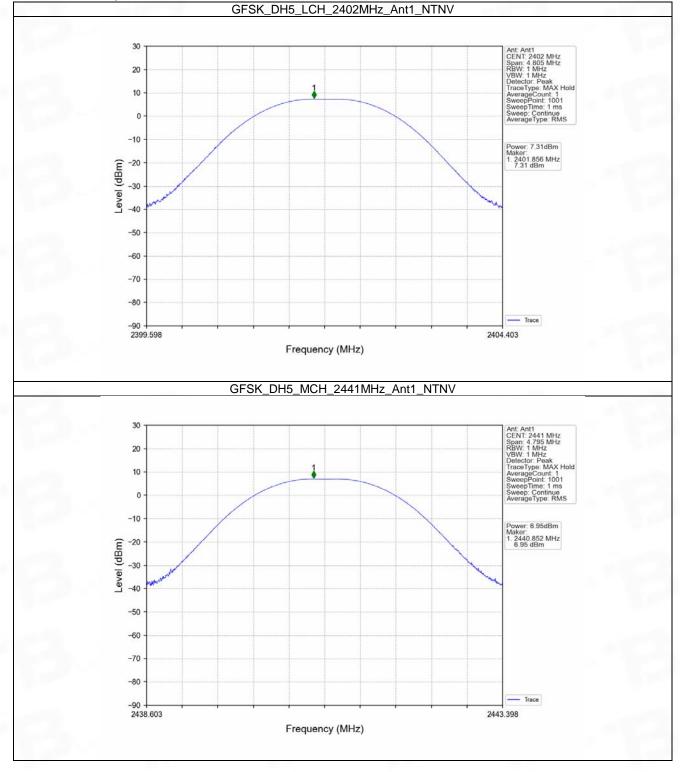
Mode	TX	Frequency	Packet	Maximum Peak Conduc	Verdict	
	Туре	(MHz)	Туре	ANT1	Limit	veruici
GFSK	SISO	2402	DH5	7.31	<=30	Pass
		2441	DH5	6.95	<=30	Pass
		2480	DH5	6.09	<=30	Pass
Pi/4DQPSK	SISO	2402	2DH5	7.48	<=20.97	Pass
		2441	2DH5	7.21	<=20.97	Pass
		2480	2DH5	6.51	<=20.97	Pass
8DPSK	SISO	2402	3DH5	7.64	<=20.97	Pass
		2441	3DH5	7.36	<=20.97	Pass
		2480	3DH5	6.75	<=20.97	Pass
Note1: Antenna	Gain: Ant1:		00110	0.70	S=20.91	1 43

Note1: Antenna Gain: Ant1: 1.15dBi

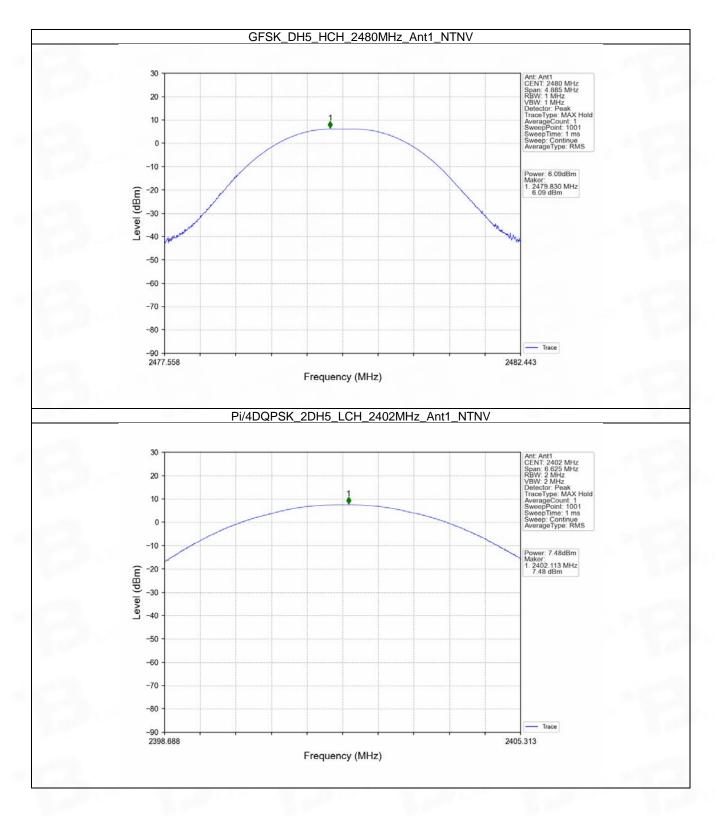
2.1 Power



2.1.2 Test Graph

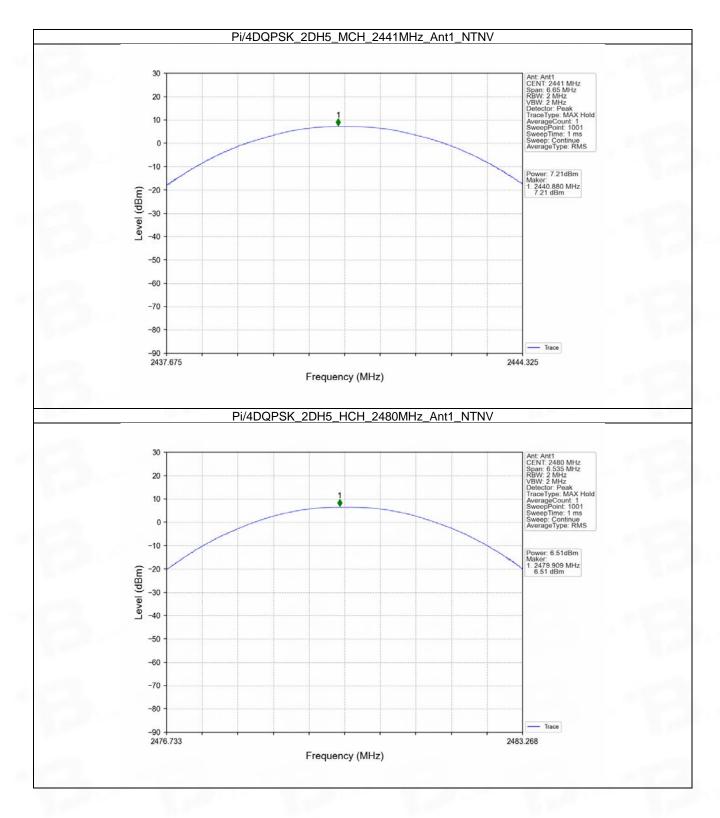






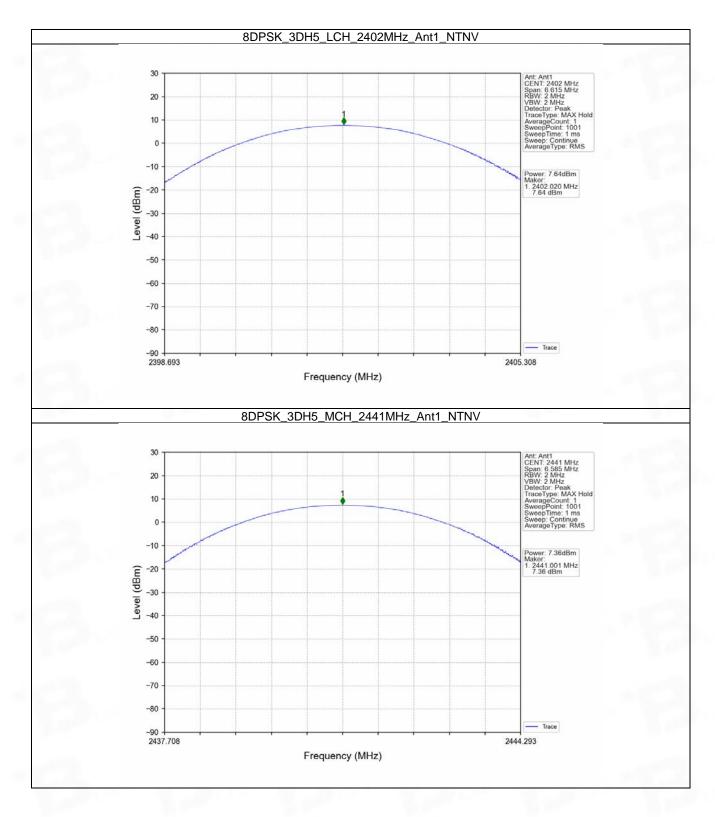
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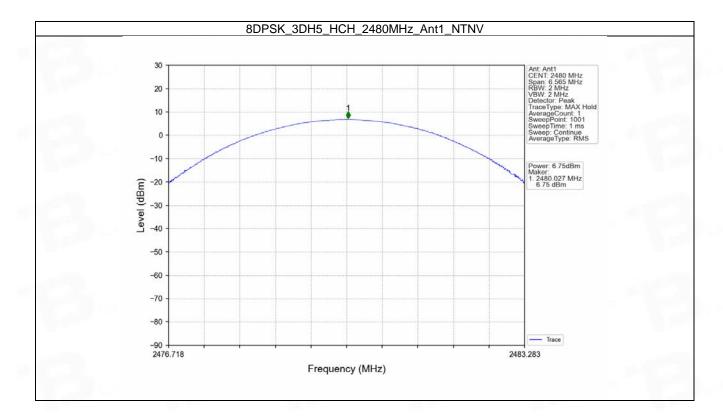
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3. Carrier Frequency Separation

3.1 Ant1

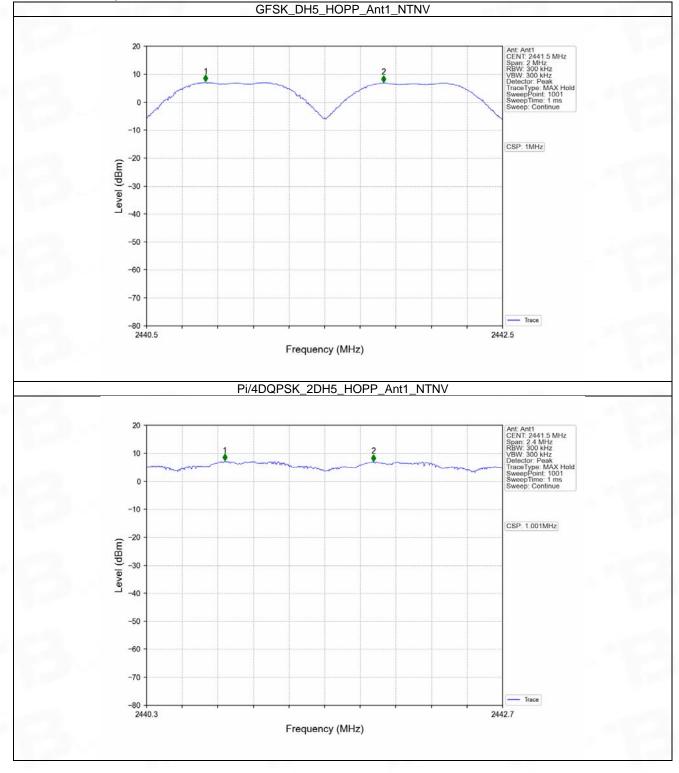
3.1.1 Test Result

Ant1									
Mode	ΤX	Frequency	Packet	Channel Separation	20dB Bandwidth	Limit	Verdict		
	Туре	(MHz)	Туре	(MHz)	(MHz)	(MHz)	verdict		
GFSK	SISO	HOPP	DH5	1.000	0.977	>=0.977	Pass		
Pi/4DQPSK	SISO	HOPP	2DH5	1.001	1.330	>=0.887	Pass		
8DPSK	SISO	HOPP	3DH5	1.001	1.323	>=0.882	Pass		

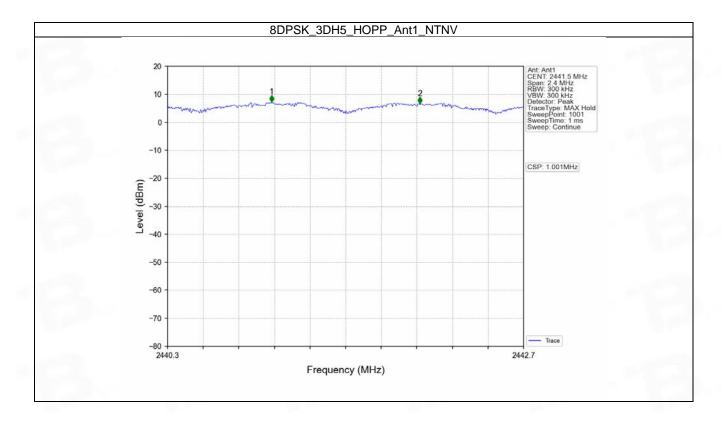
3.1 Ant1



3.1.2 Test Graph









4. Number of Hopping Frequencies

4.1 HoppNum

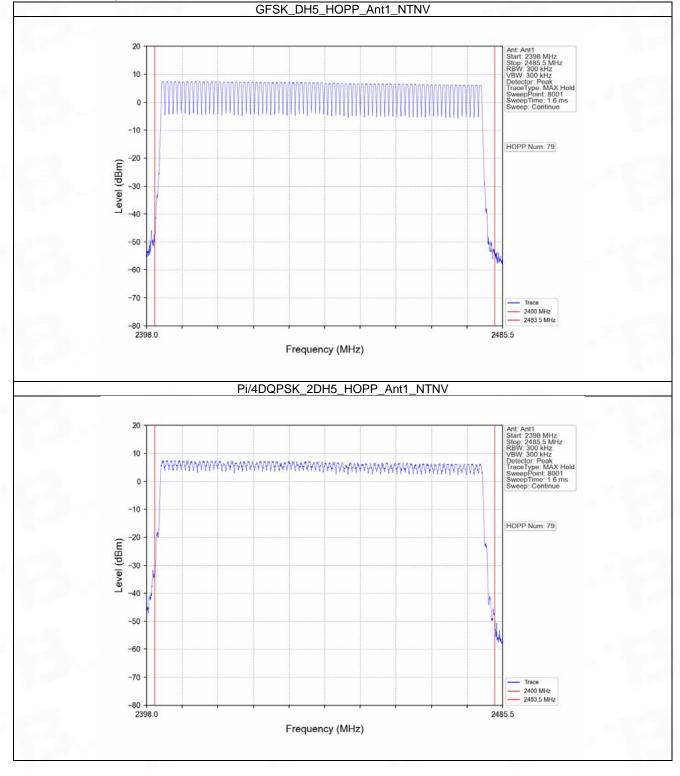
4.1.1 Test Result

Mode	TX	Frequency	Packet	Num of Hoppin	Verdict	
	Туре	(MHz)	Туре	ANT1	Limit	veruici
GFSK	SISO	HOPP	DH5	79	>=15	Pass
Pi/4DQPSK	SISO	HOPP	2DH5	79	>=15	Pass
8DPSK	SISO	HOPP	3DH5	79	>=15	Pass

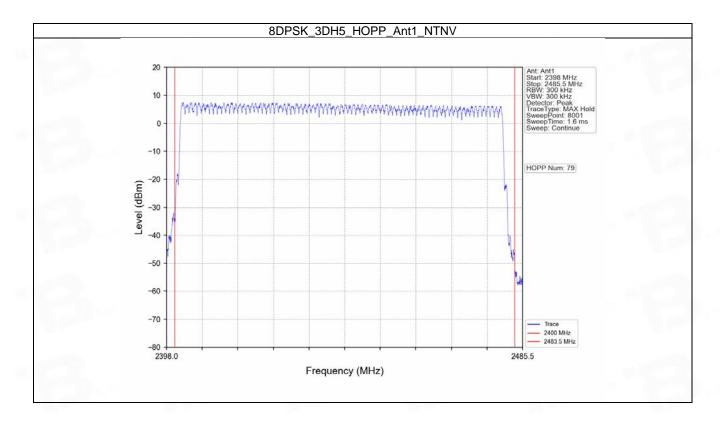
4.1 HoppNum



4.1.2 Test Graph









5. Time of Occupancy (Dwell Time)

5.1 Ant1

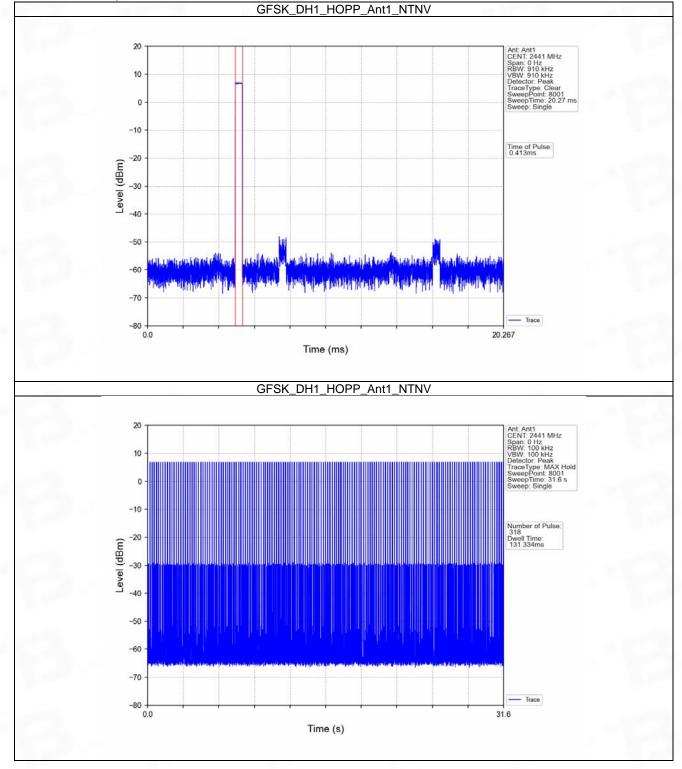
5.1.1 Test Result

	Ant1										
Mode	ΤX	Frequency Packet		Packet Duration of		Num of Pulse in	Dwell	Dwell Limit	Verdict		
Node	Туре	(MHz)	Туре	Single Pulse (ms)	Period (s)	Observation Period	Time (ms)	(ms)	verdict		
		ISO HOPP	DH1	0.413	31.600	318	131.334	<=400	Pass		
GFSK SIS	SISO		DH3	1.669	31.600	163	272.047	<=400	Pass		
			DH5	2.918	31.600	117	341.406	<=400	Pass		
	SISO	SO HOPP	2DH1	0.420	31.600	318	133.560	<=400	Pass		
Pi/4DQPSK			2DH3	1.672	31.600	153	255.816	<=400	Pass		
						2DH5	2.926	31.600	111	324.786	<=400
		SISO HOPP	3DH1	0.423	31.600	316	133.668	<=400	Pass		
8DPSK	SISO		3DH3	1.674	31.600	165	276.210	<=400	Pass		
			3DH5	2.926	31.600	95	277.970	<=400	Pass		

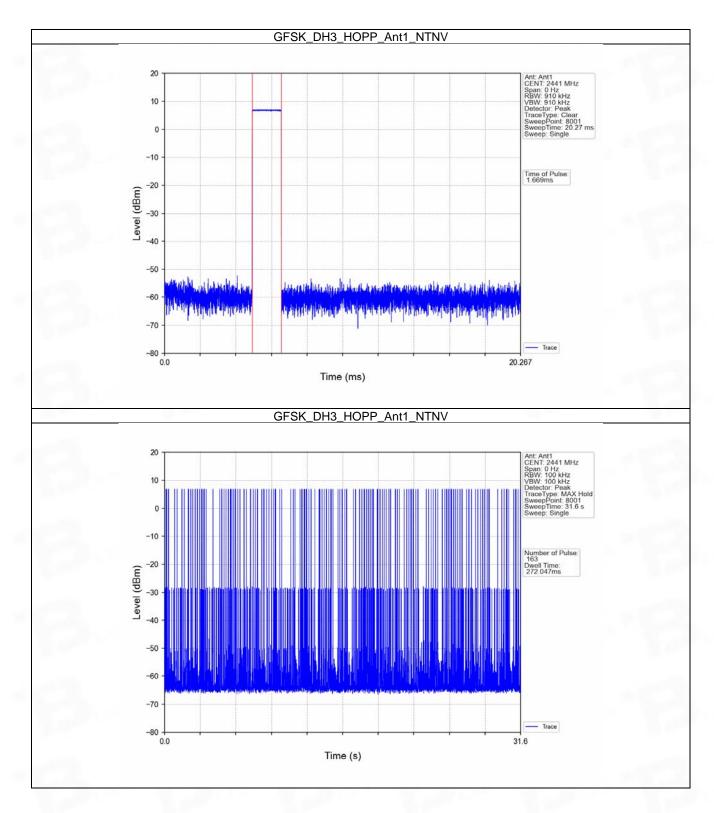
5.1 Ant1



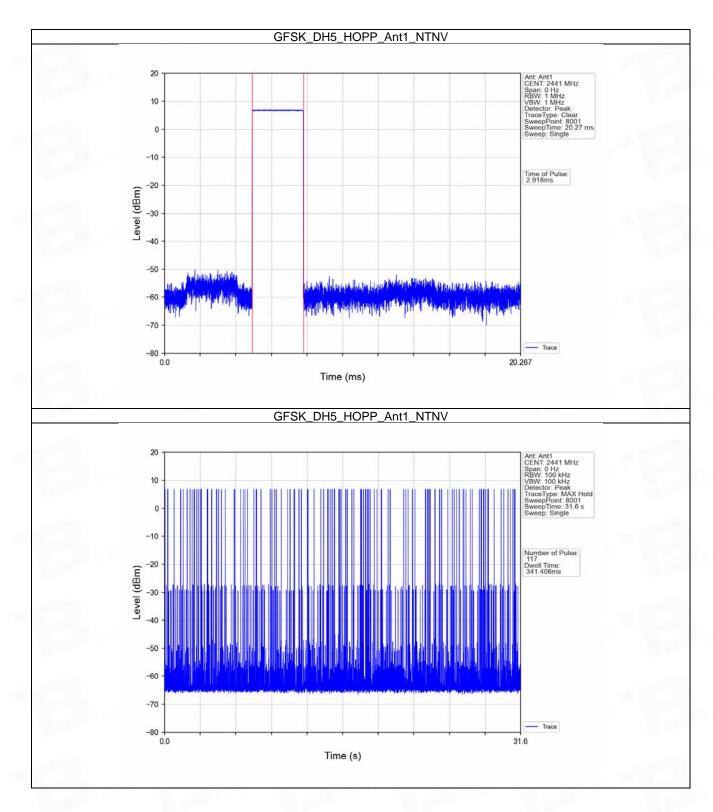
5.1.2 Test Graph



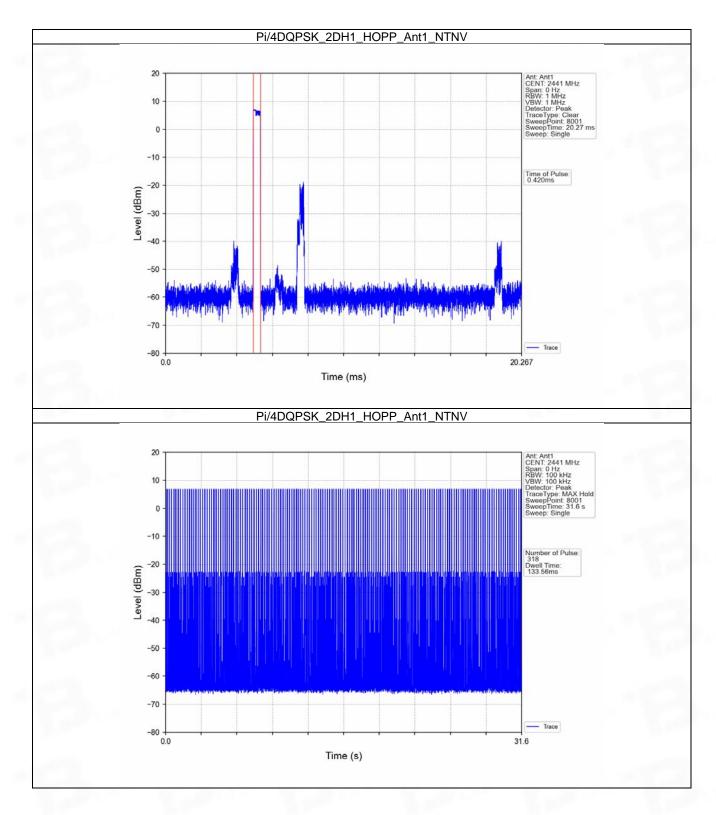






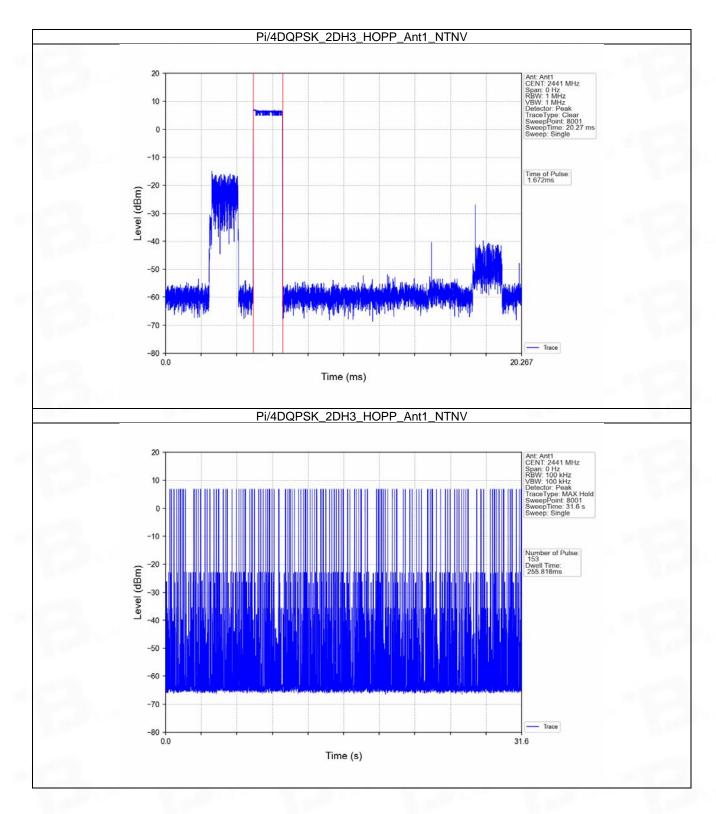






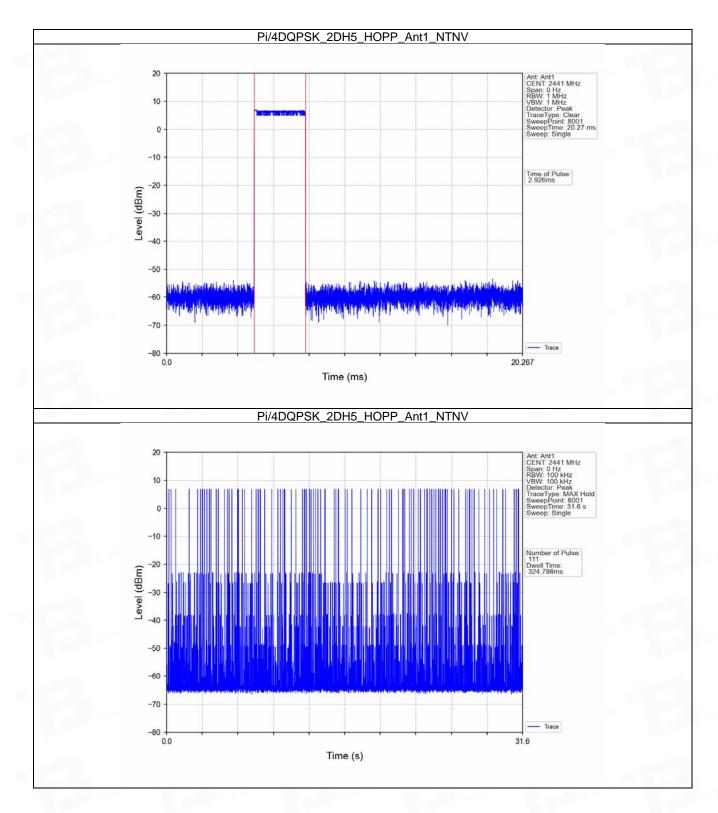
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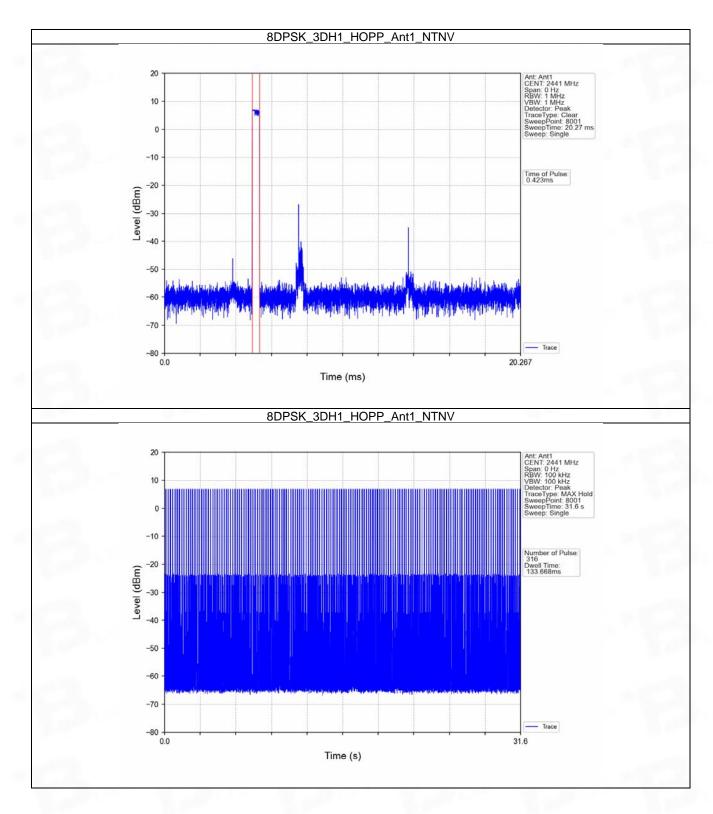


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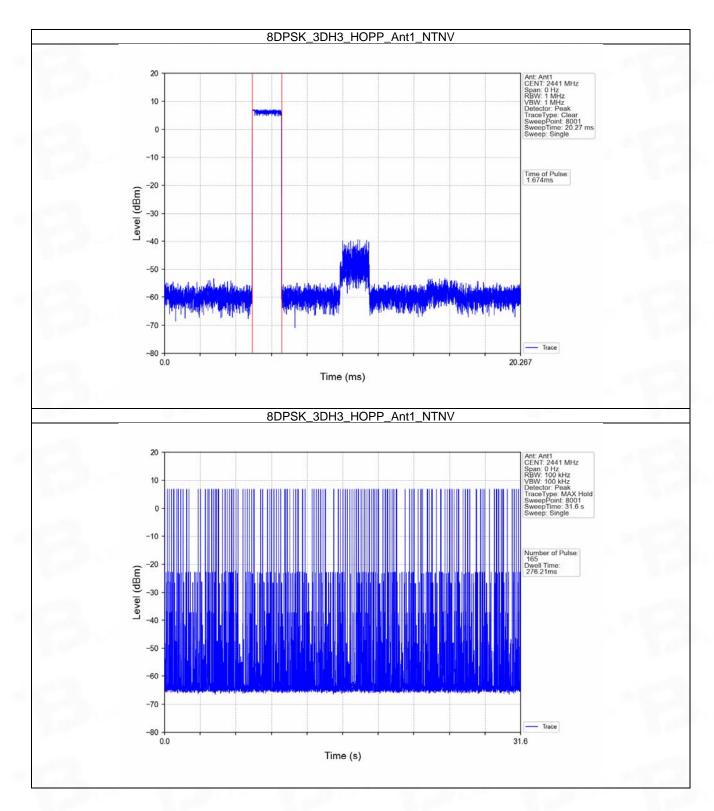






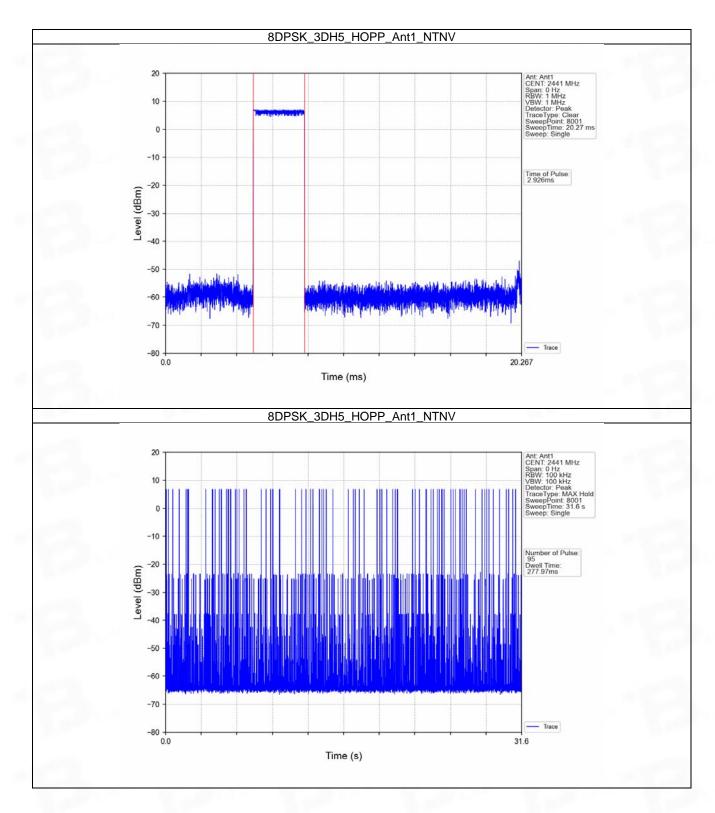






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6. Unwanted Emissions In Non-restricted Frequency Bands

6.1 Ref

6.1.1 Test Result

Mode	TX Type	Frequency (MHz)	Packet Type	ANT	Level of Reference (dBm)
GFSK	SISO	2402	DH5	1	7.31
		2441	DH5	1	6.91
		2480	DH5	1	6.01
Pi/4DQPSK	SISO	2402	2DH5	1	7.26
		2441	2DH5	1	6.90
		2480	2DH5	1	6.02
8DPSK	SISO	2402	3DH5	1	7.27
		2441	3DH5	1	6.92
		2480	3DH5	1	6.03

6.2 CSE

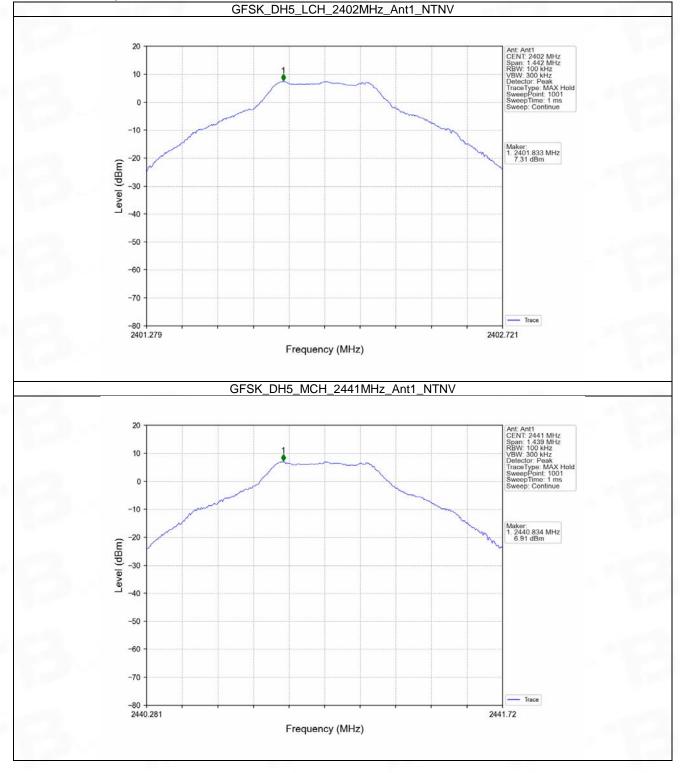
6.2.1 Test Result

Mode	ТХ Туре	Frequency (MHz)	Packet Type	ANT	Level of Reference (dBm)	Limit (dBm)	Verdict
GFSK SISO		2402	DH5	1	7.31	-12.69	Pass
		2441	DH5	1	7.31	-12.69	Pass
	SISO	2480	DH5	1	7.31	-12.69	Pass
		HOPP	DH5	1	7.31	-12.69	Pass
					7.31	-12.69	Pass
Pi/4DQPSK SISO		2402	2DH5	1	7.26	-12.74	Pass
		2441	2DH5	1	7.26	-12.74	Pass
	SISO	2480	2DH5	1	7.26	-12.74	Pass
		HOPP	2DH5	1	7.26	-12.74	Pass
					7.26	-12.74	Pass
8DPSK S		2402	3DH5	1	7.27	-12.73	Pass
	SISO	2441	3DH5	1	7.27	-12.73	Pass
		2480	3DH5	1	7.27	-12.73	Pass
		HOPP	3DH5	1	7.27	-12.73	Pass
					7.27	-12.73	Pass

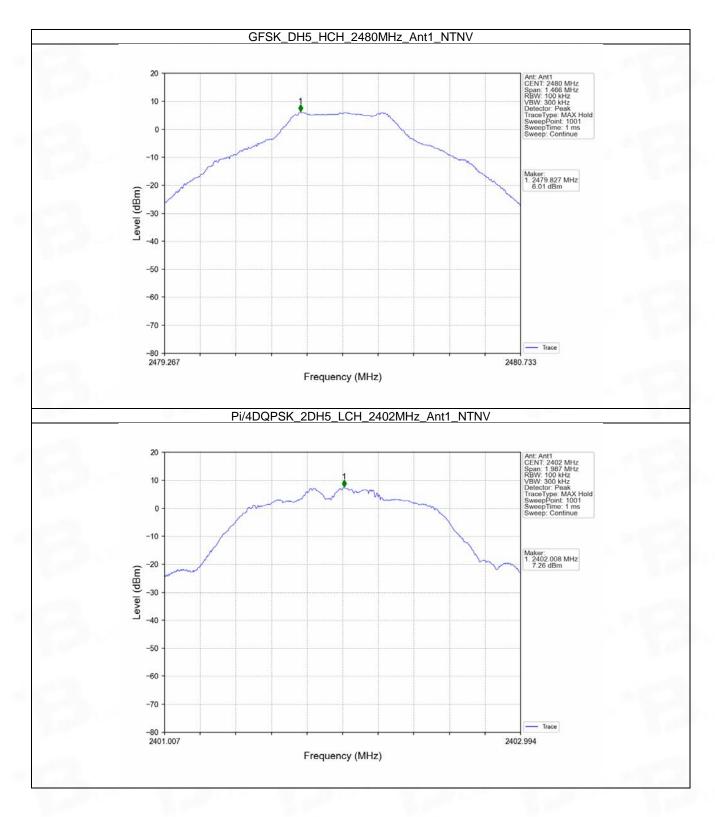
6.1 Ref



6.1.2 Test Graph

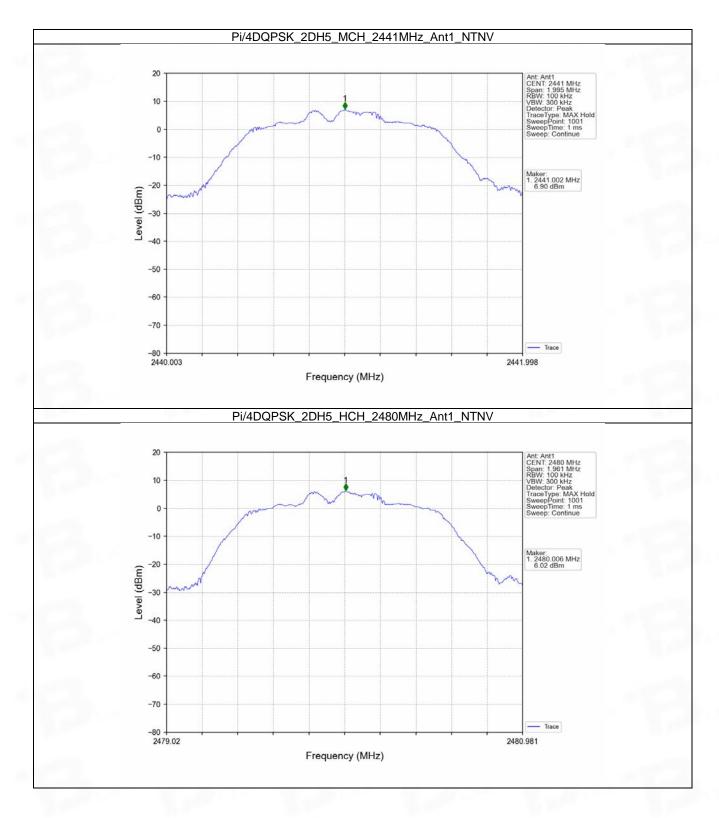






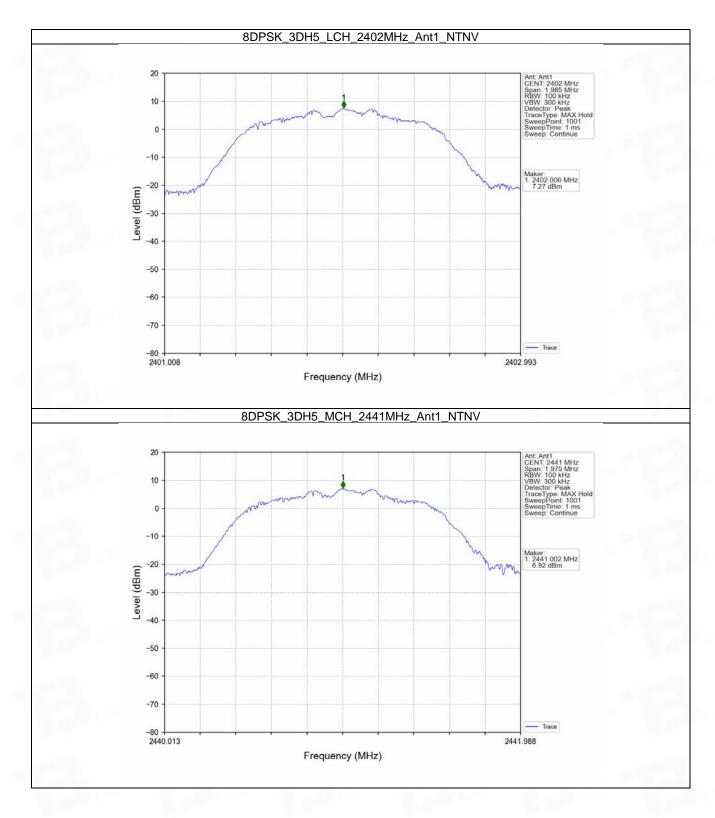
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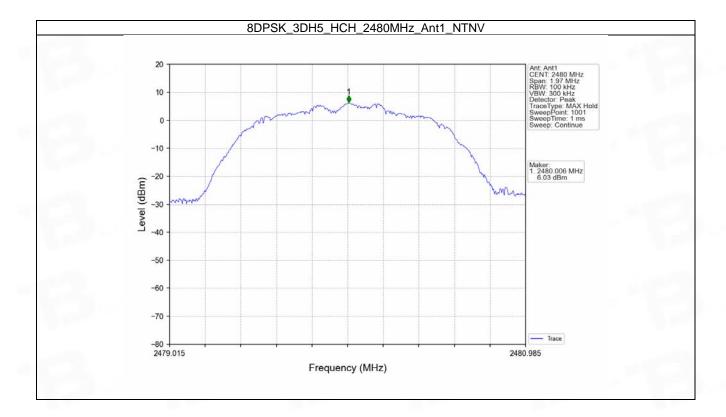
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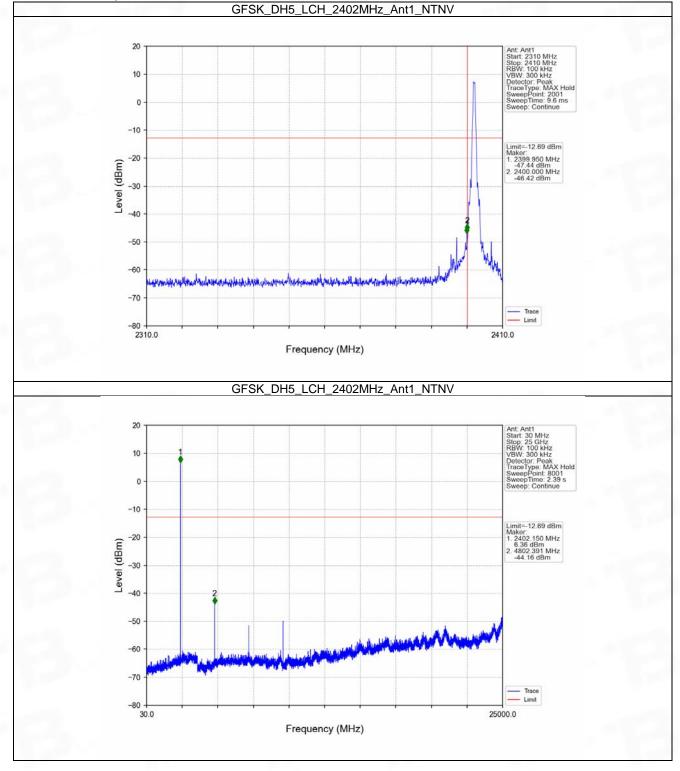


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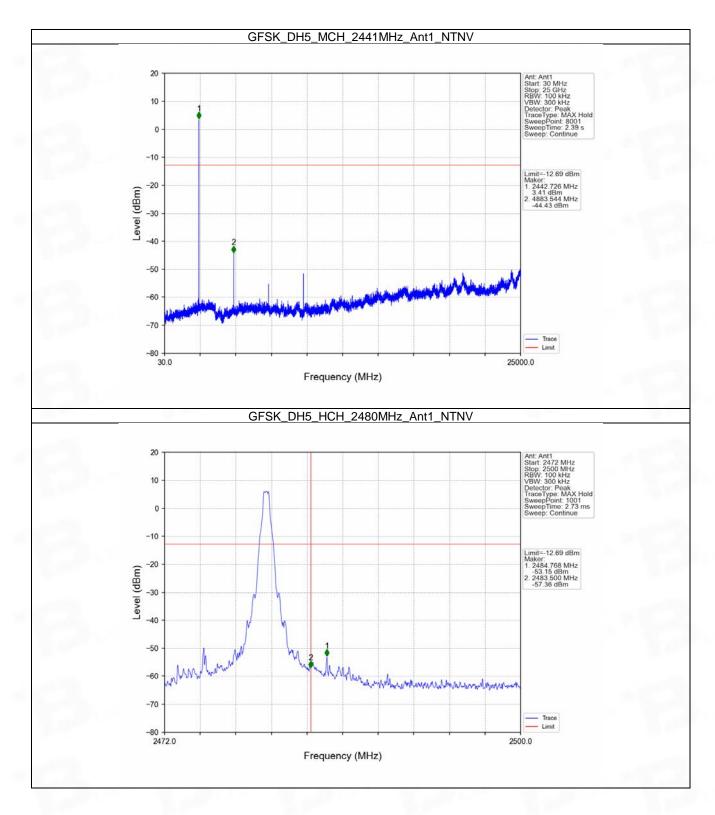
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6.2.2 Test Graph

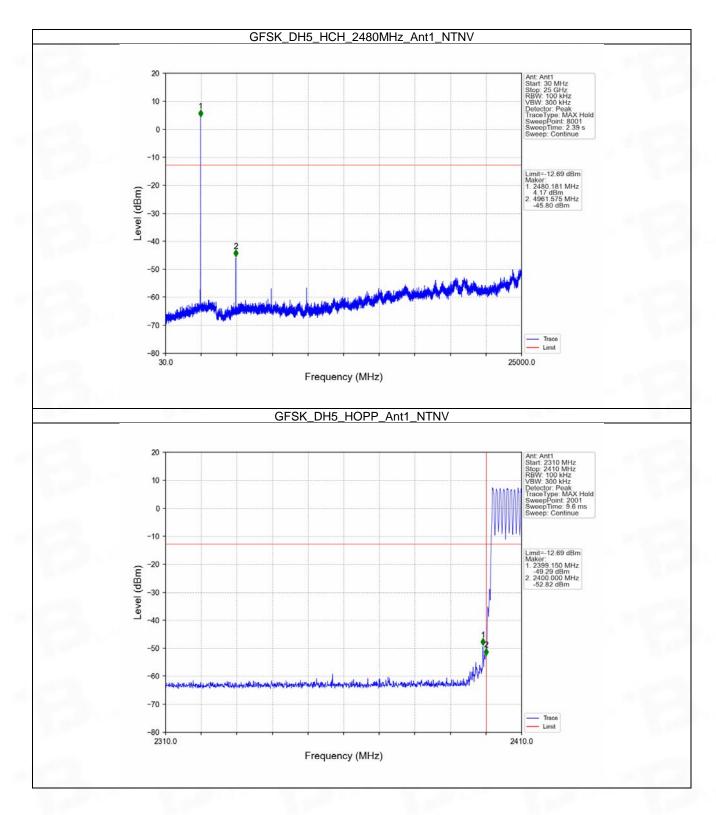






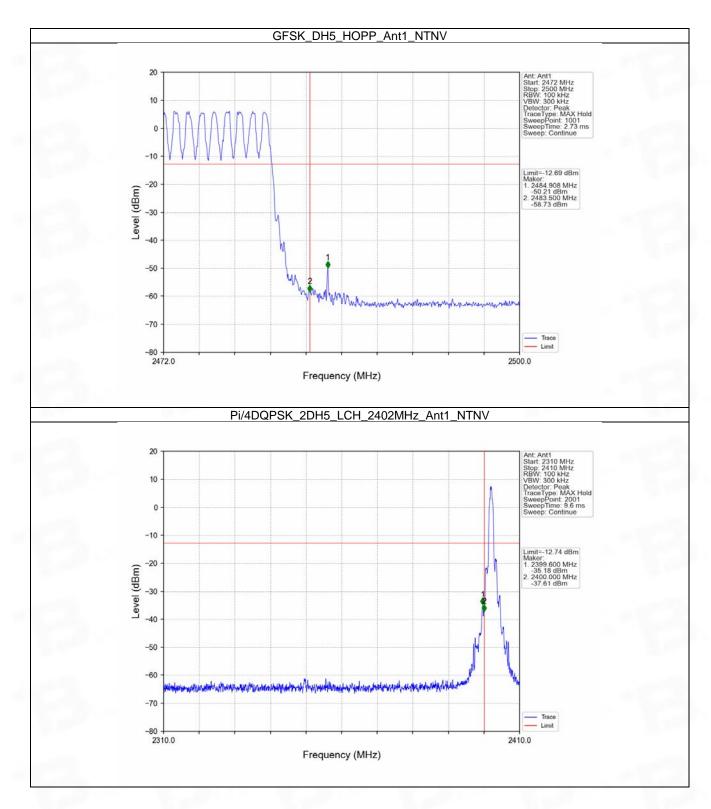
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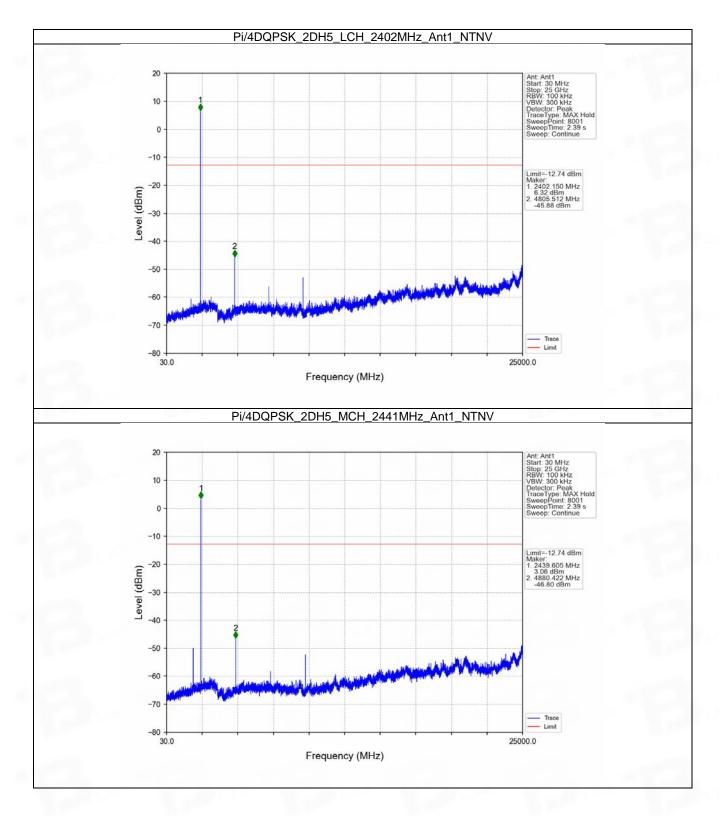
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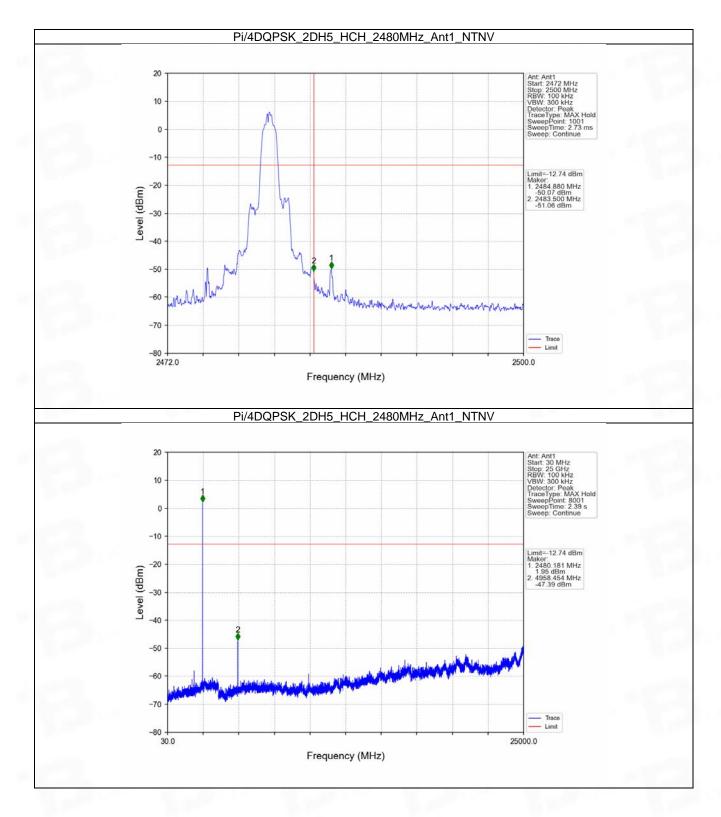
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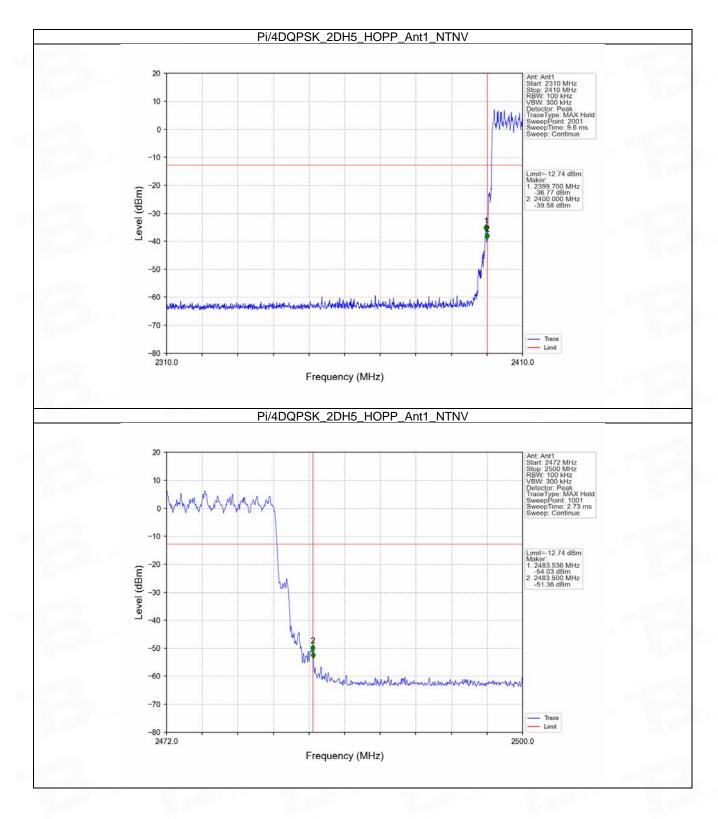
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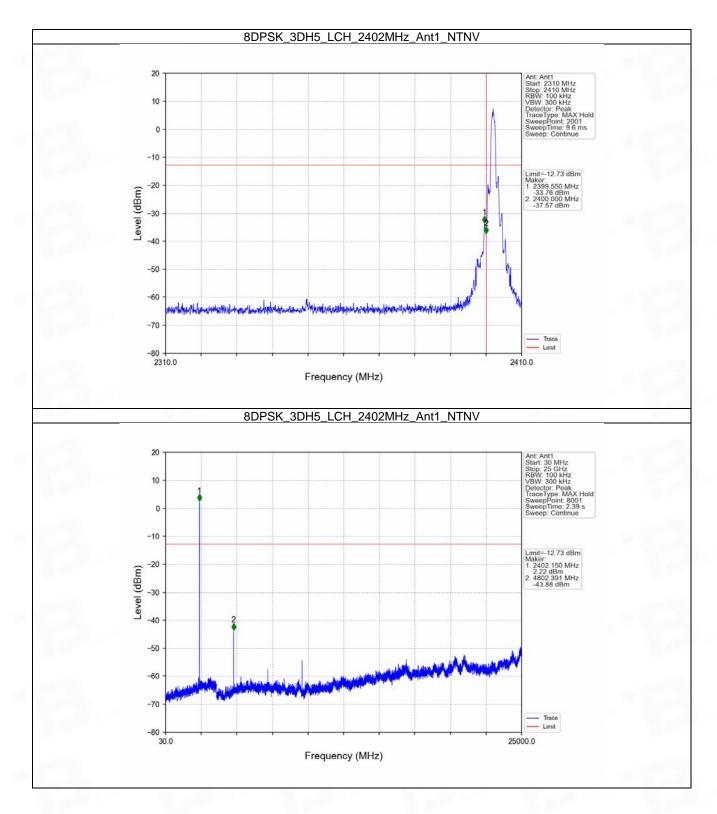
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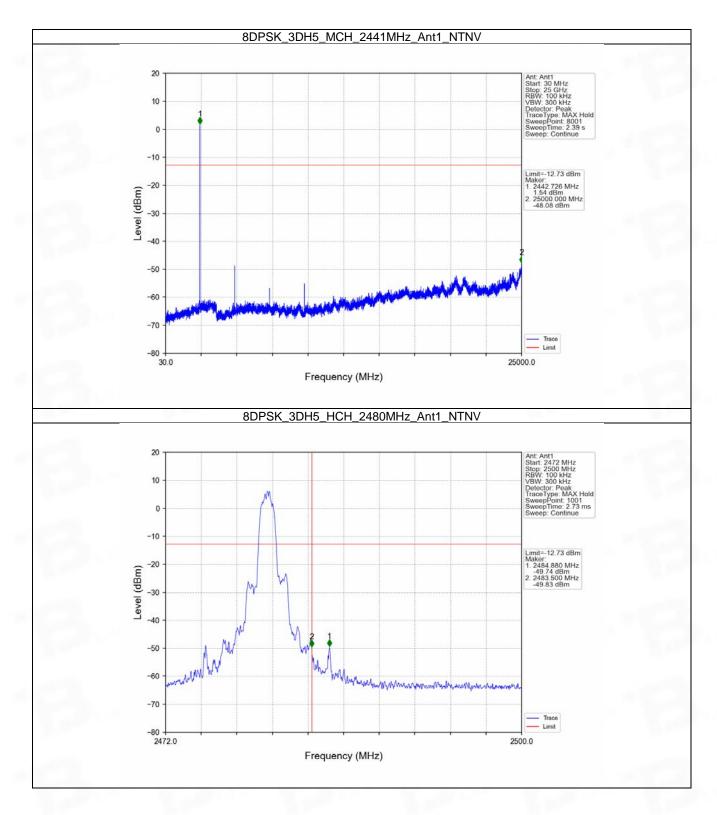
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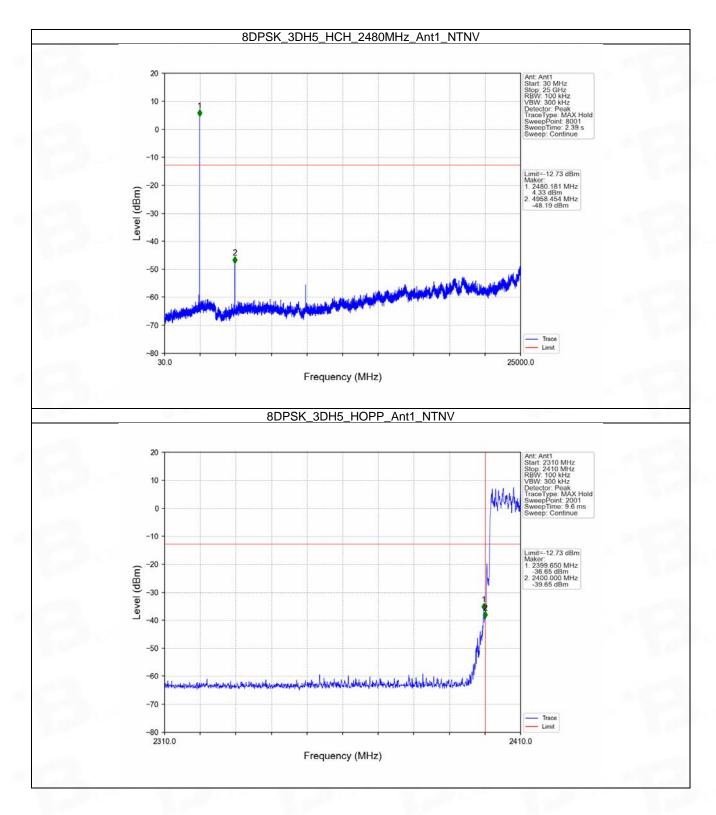
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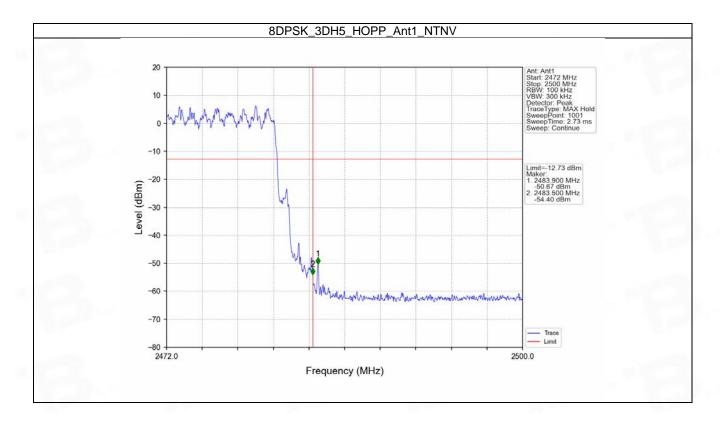
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7. Form731

7.1 Form731

7.1.1 Test Result

Lower Freq (MHz)	High Freq (MHz)	MAX Power (W)	MAX Power (dBm)
2402	2480	0.0058	7.64





BTF Testing Lab (Shenzhen) Co., Ltd.

F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

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